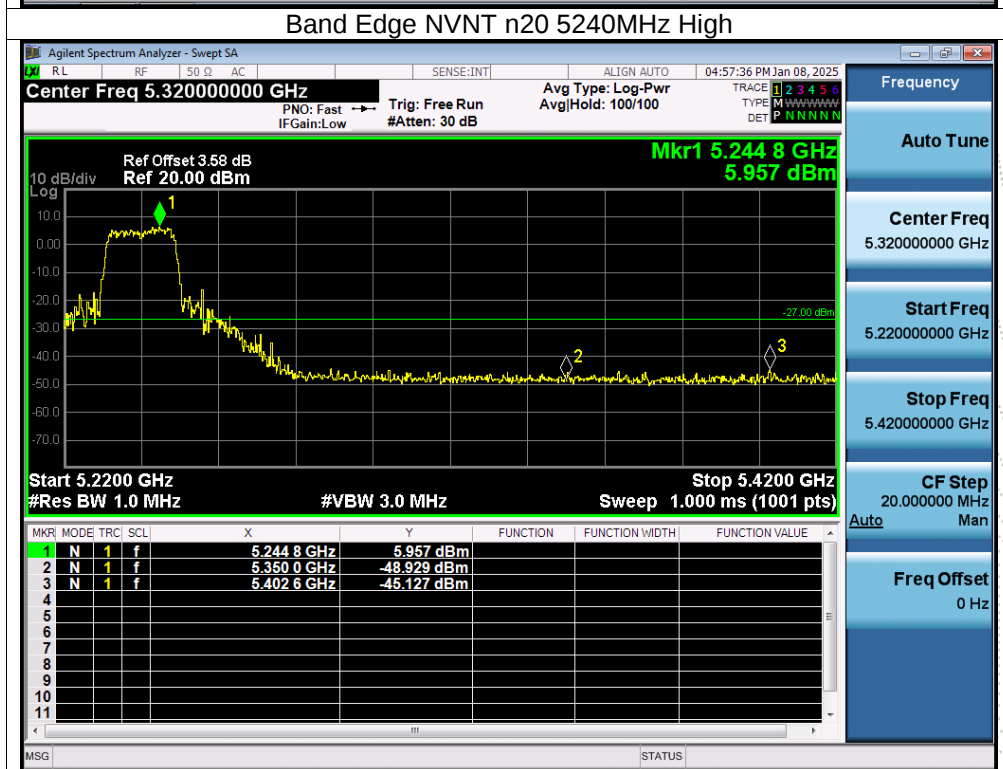
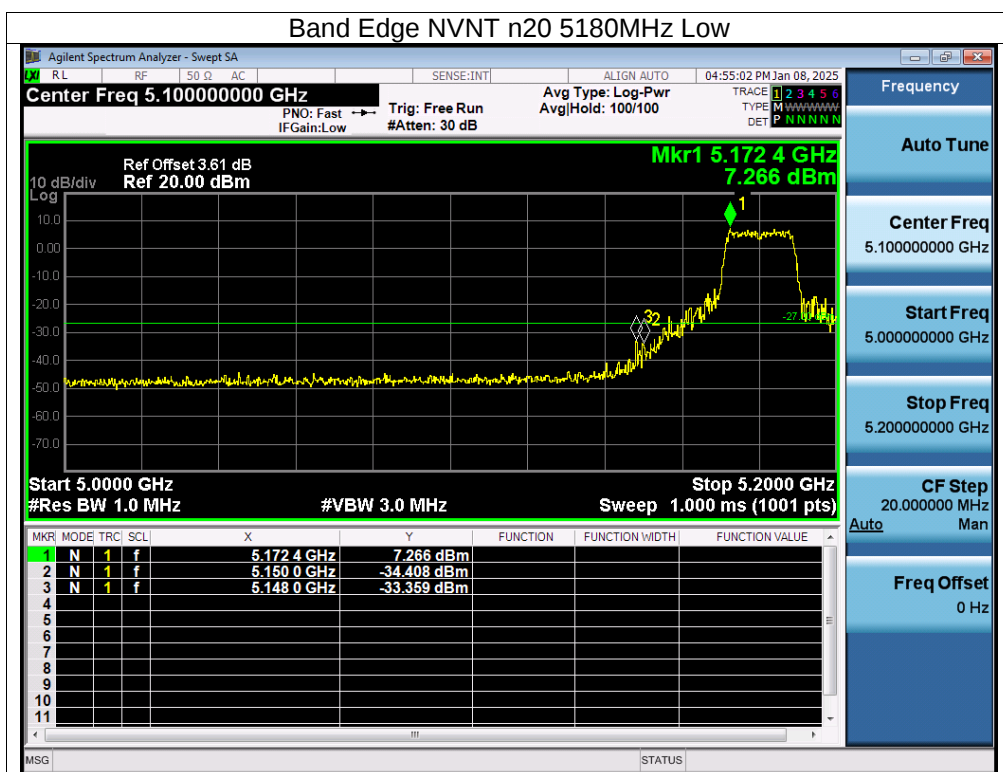
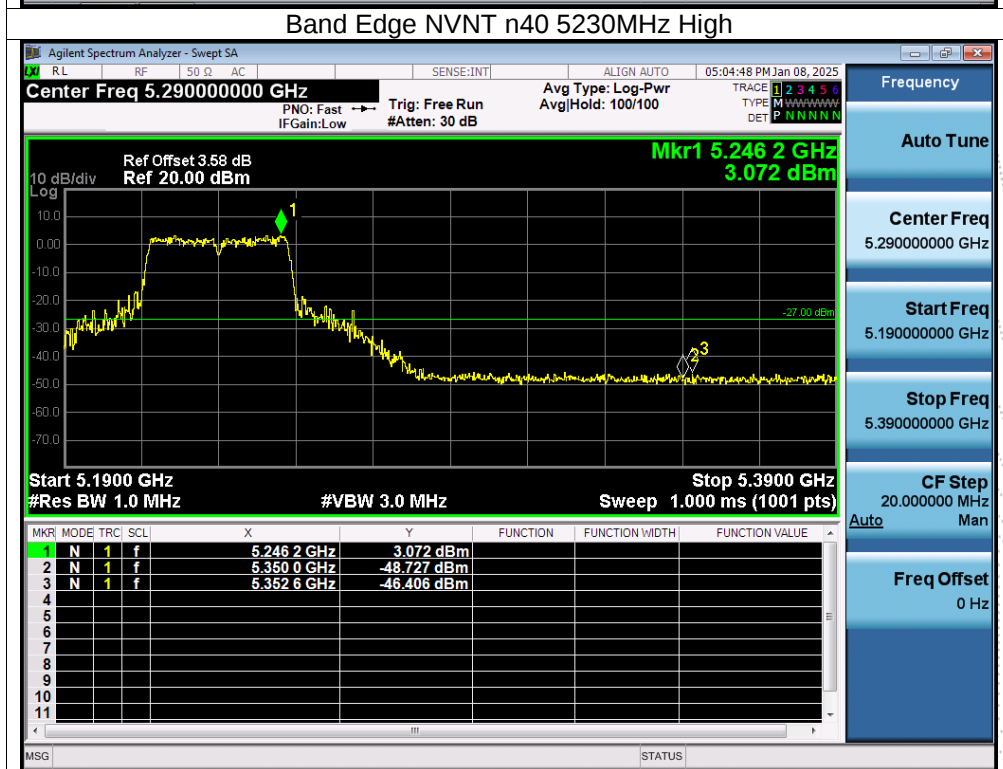
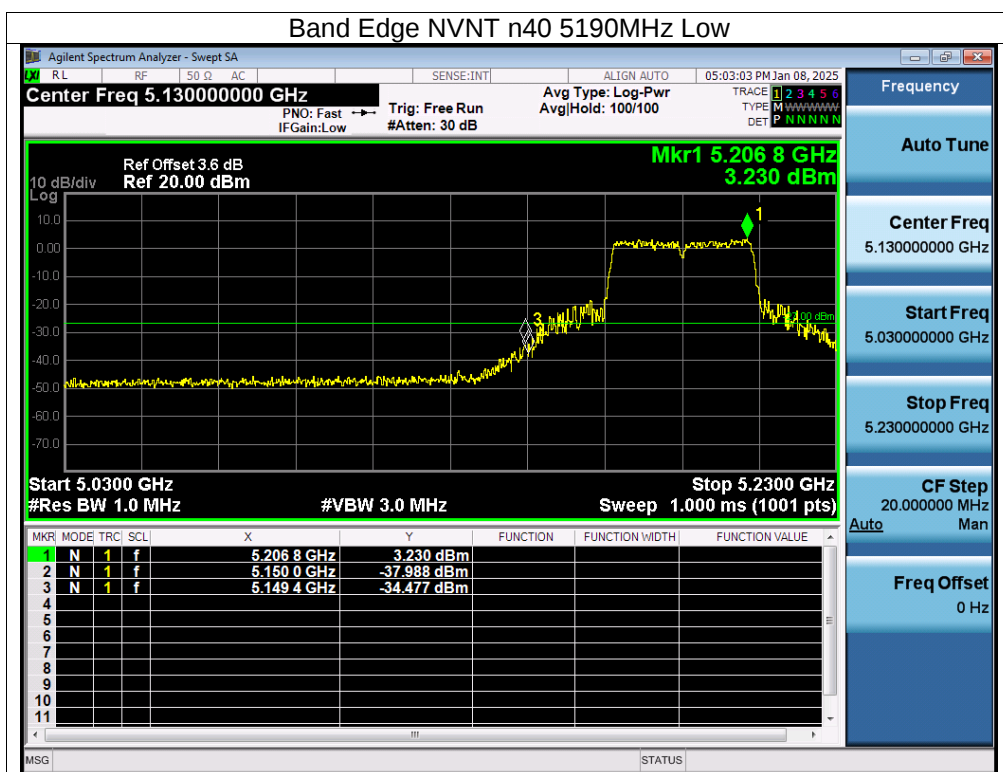
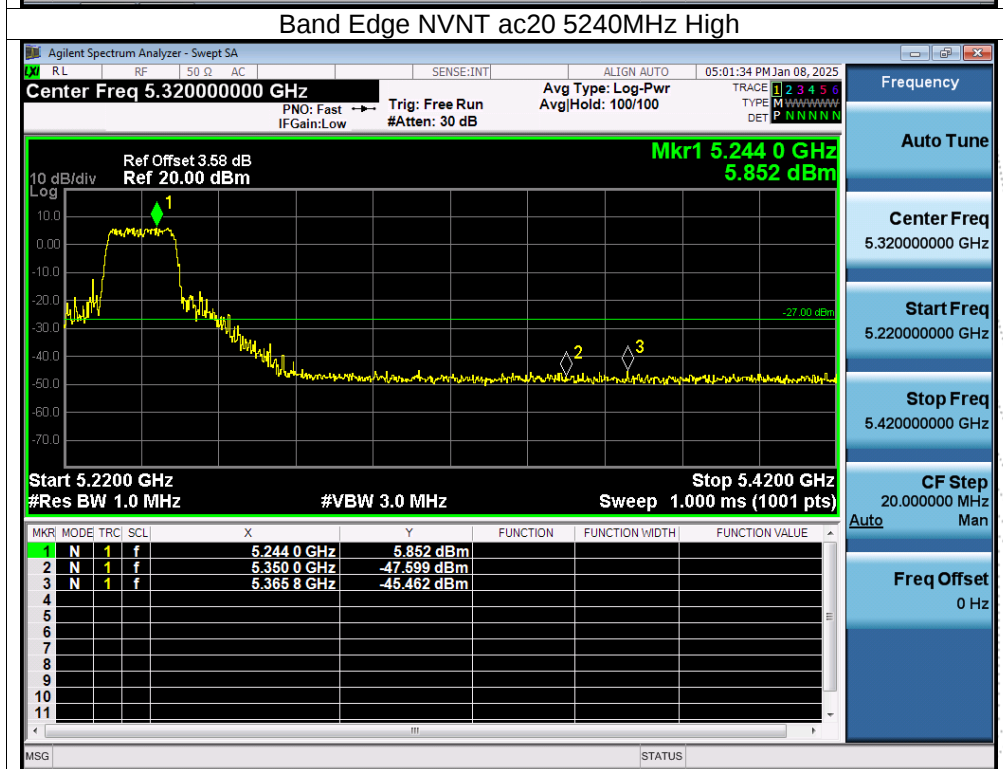
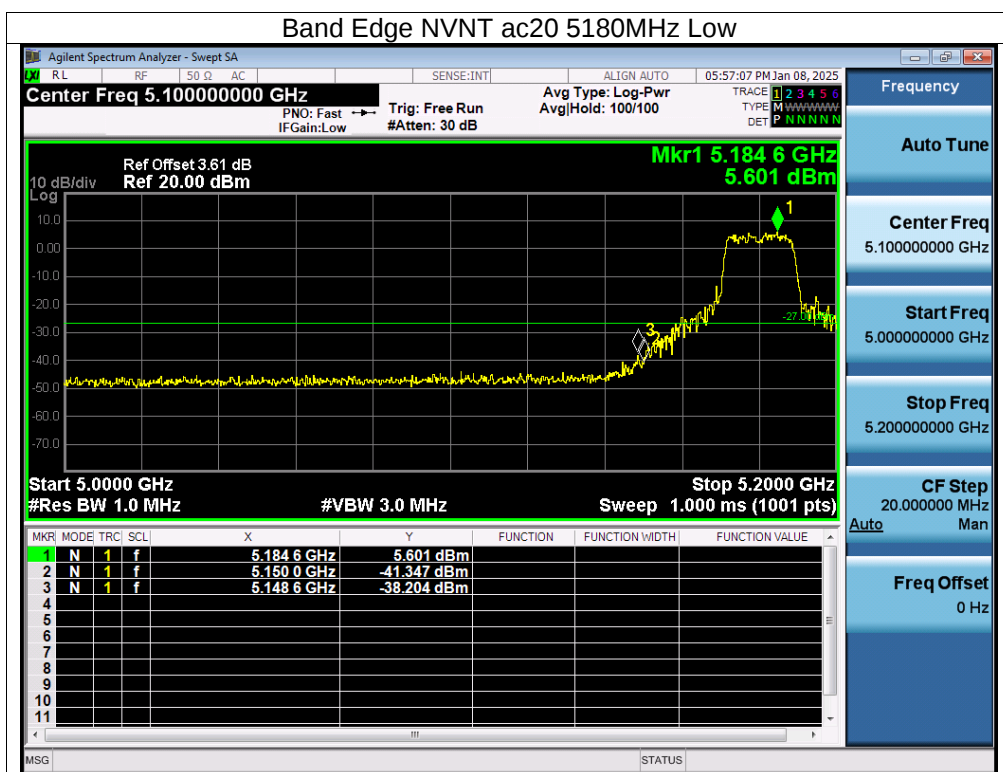
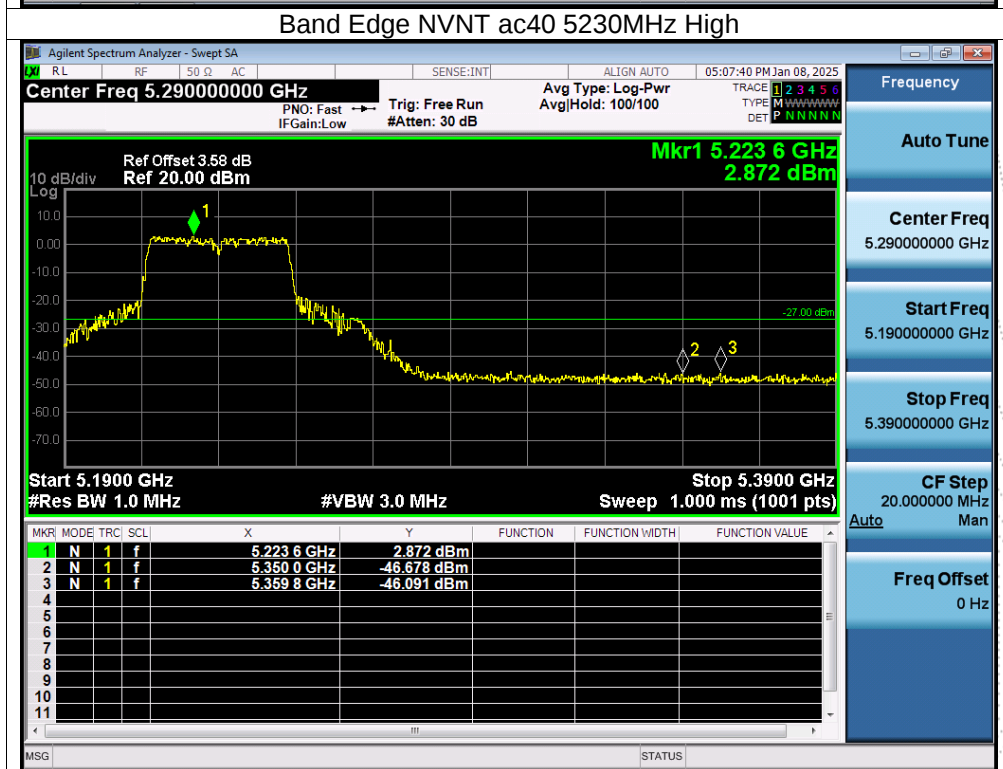
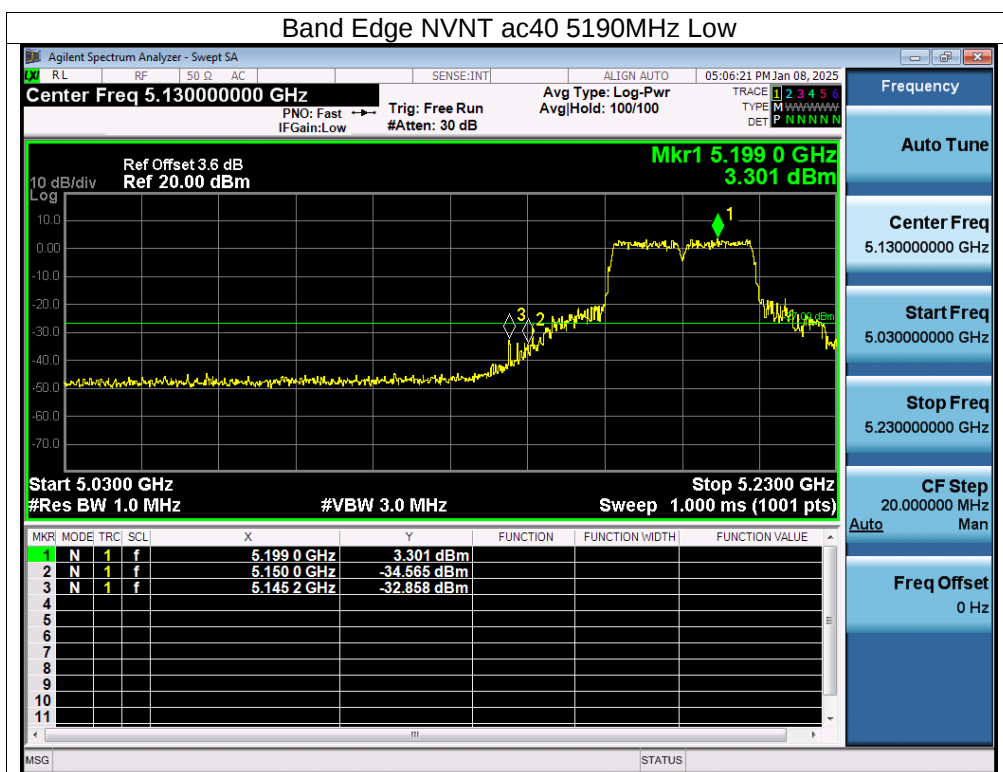
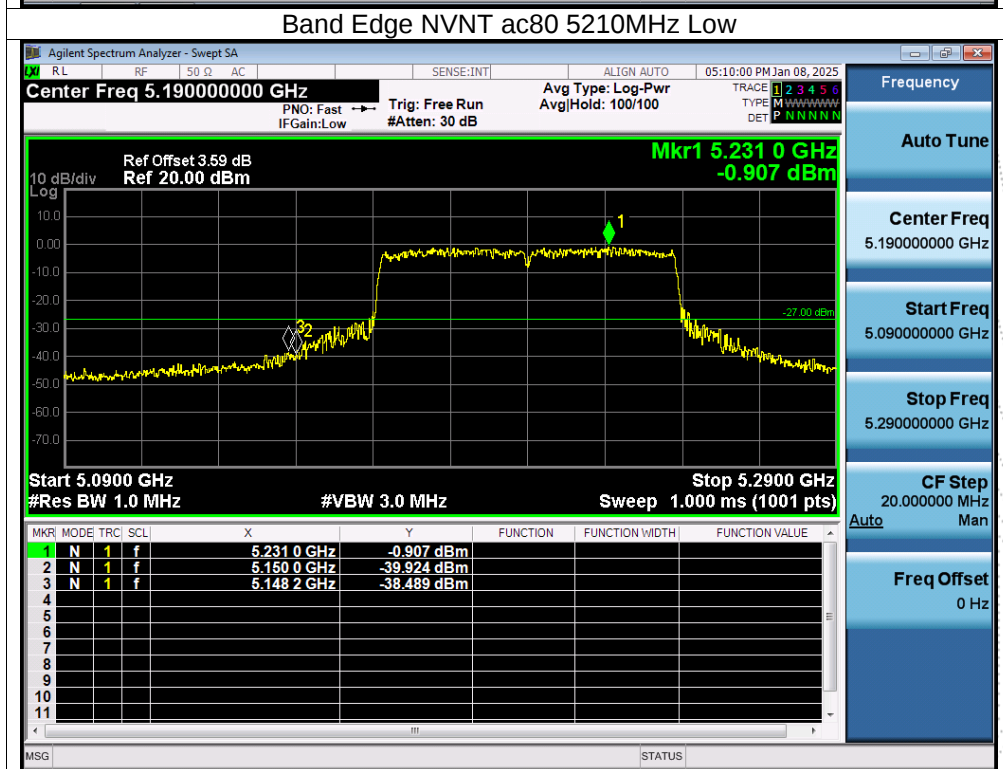
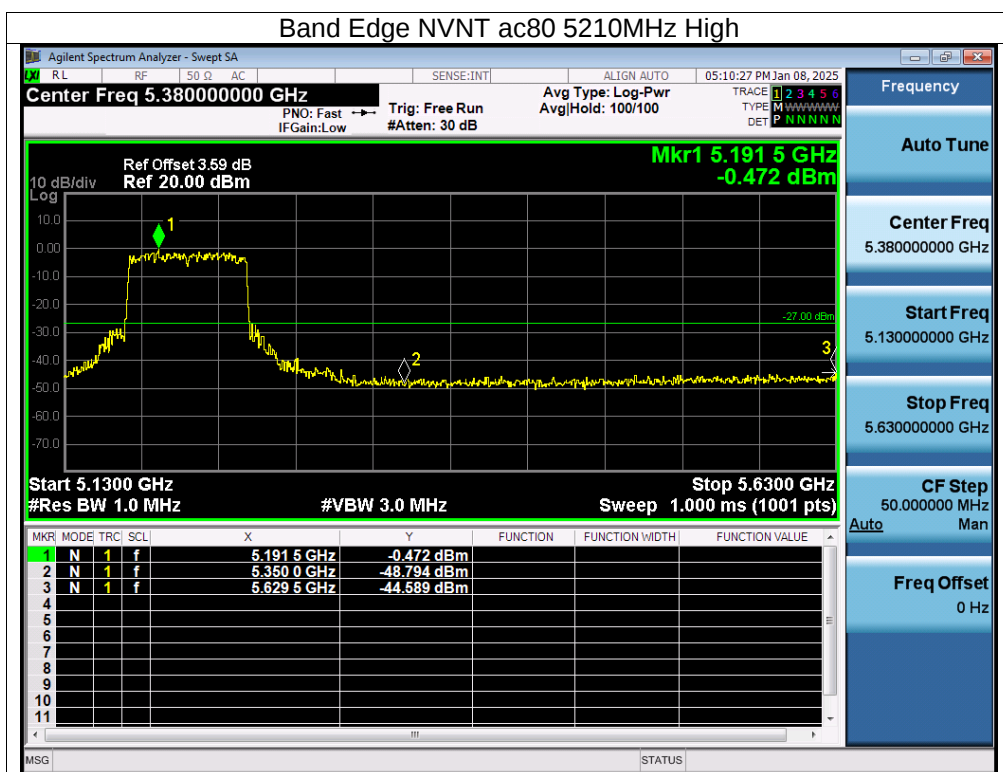






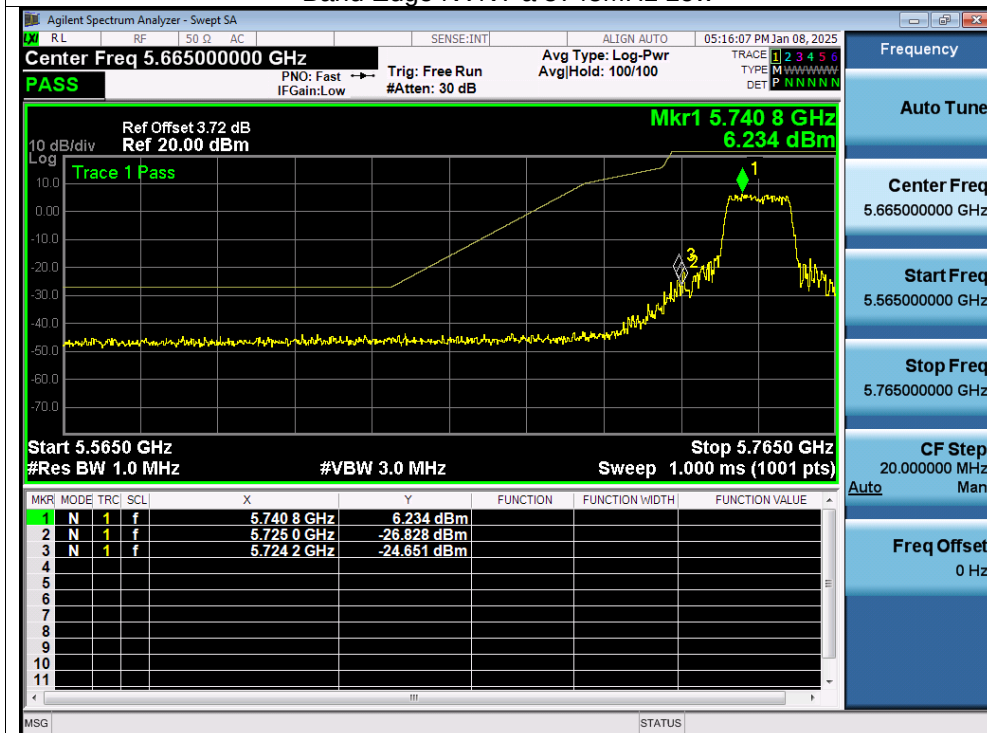




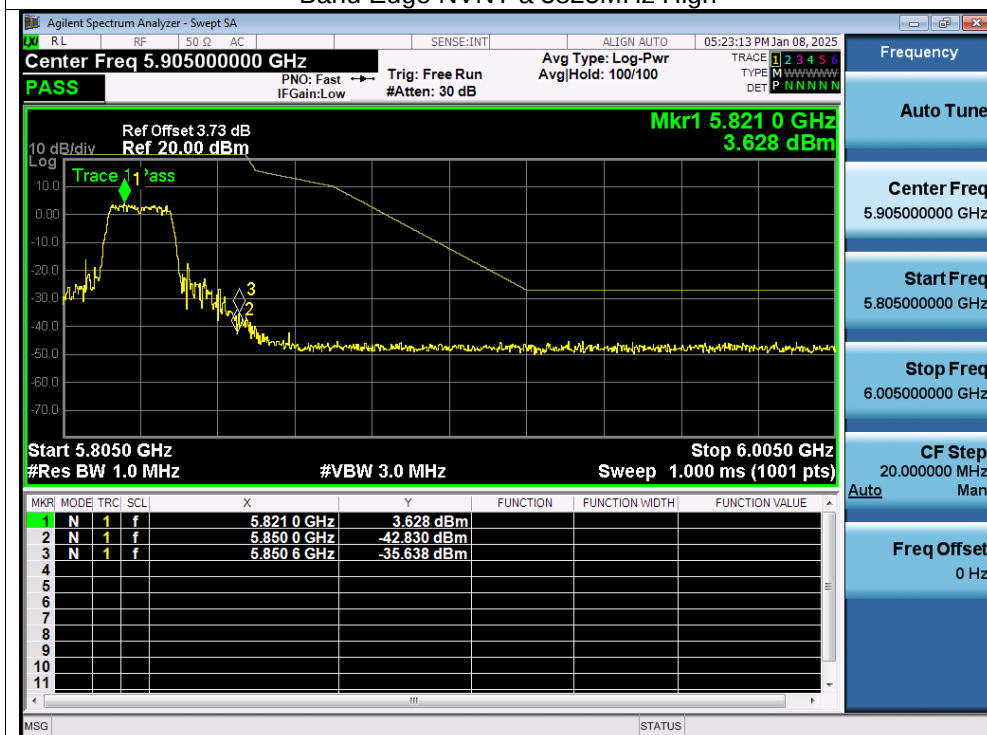


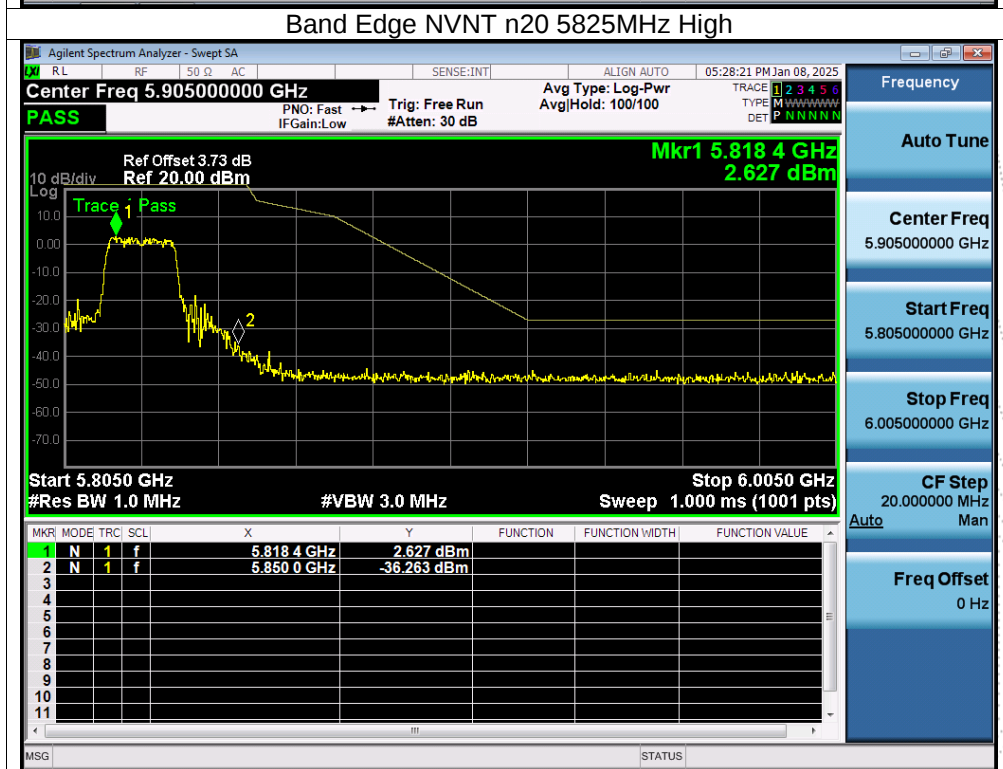
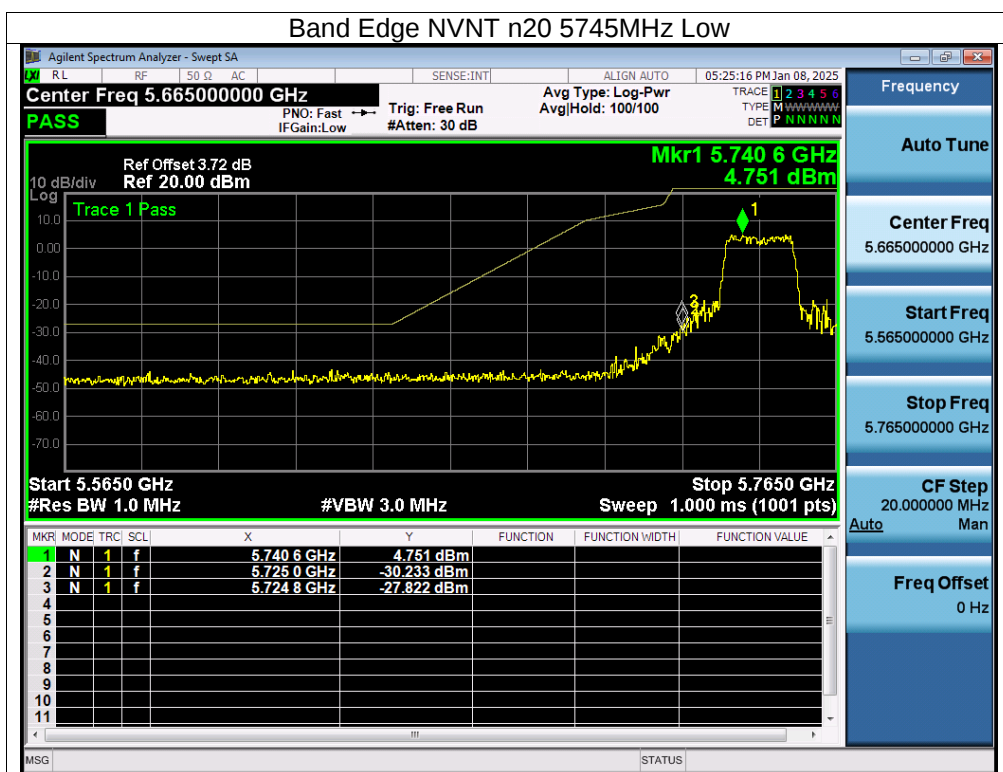
Test Graphs

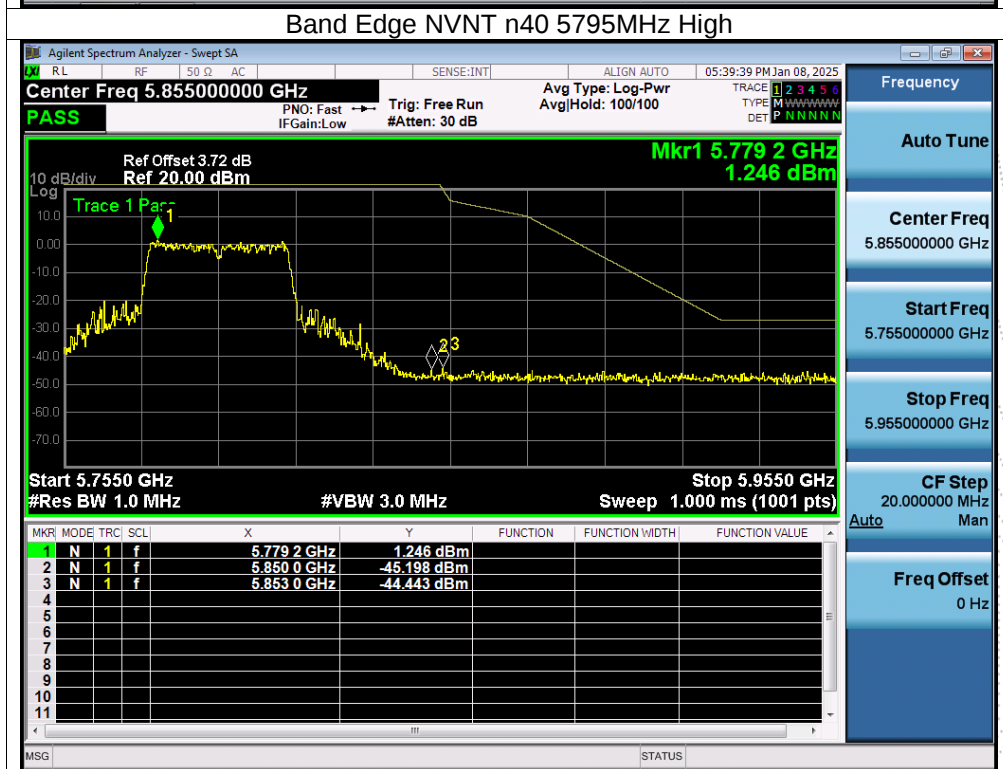
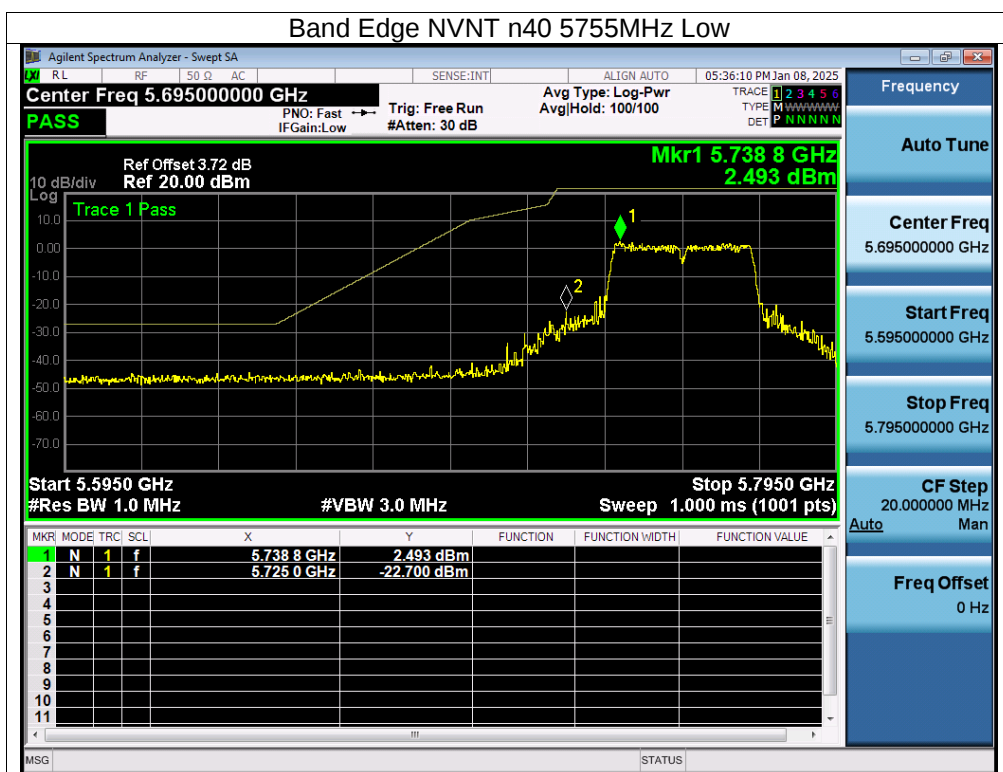
Band Edge NVNT a 5745MHz Low

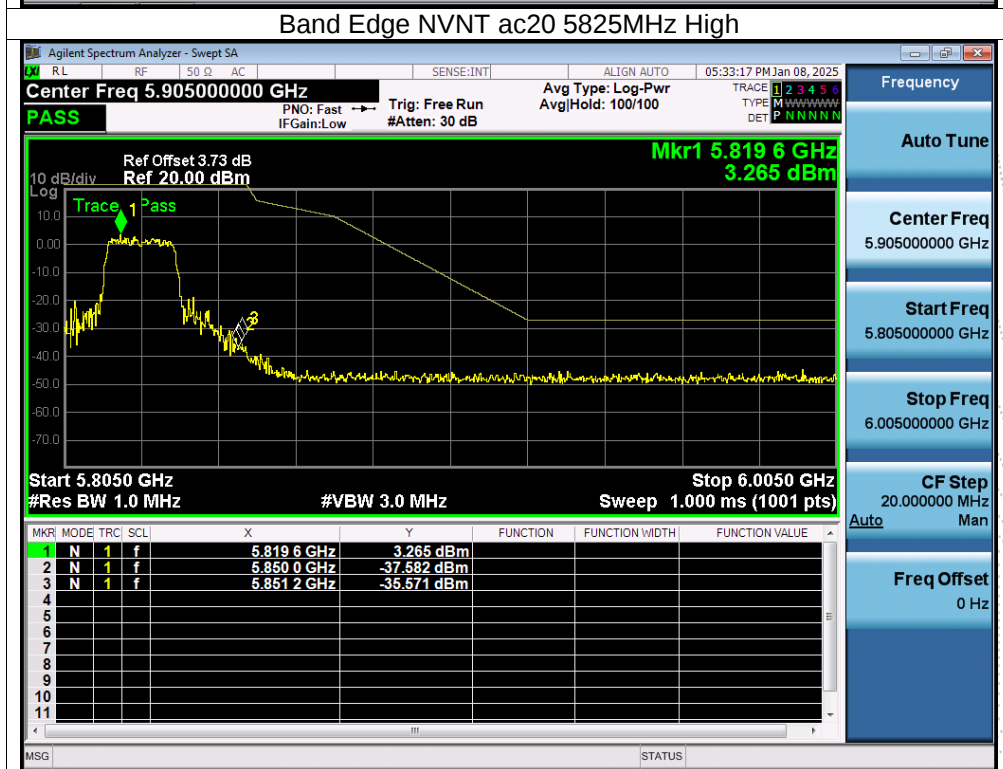
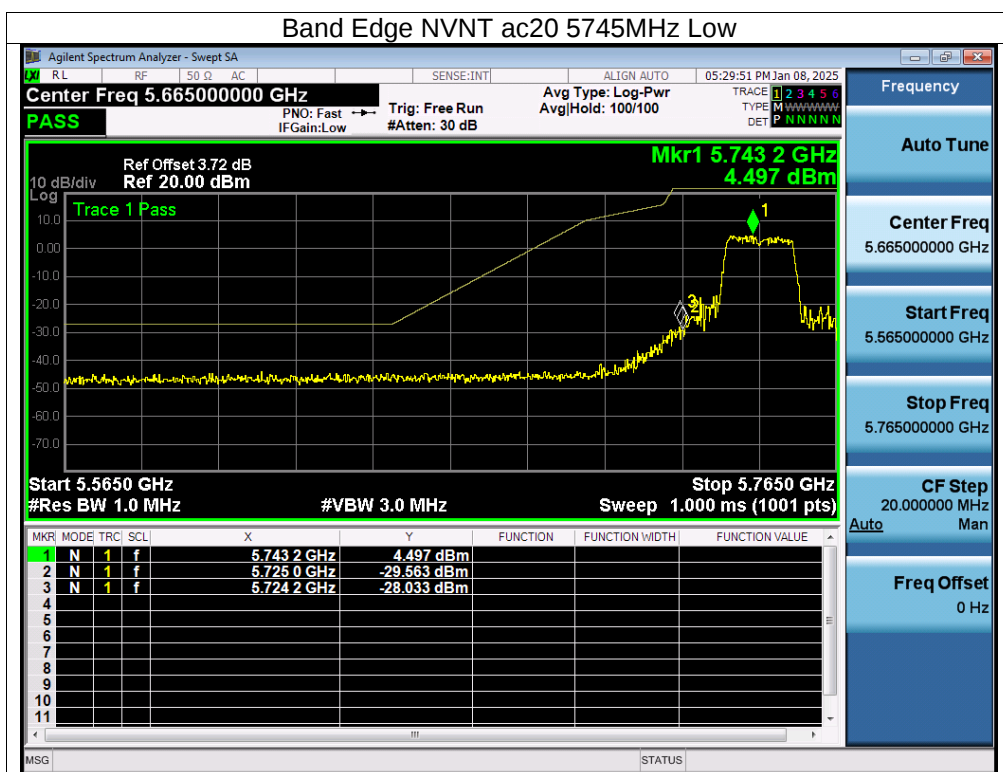


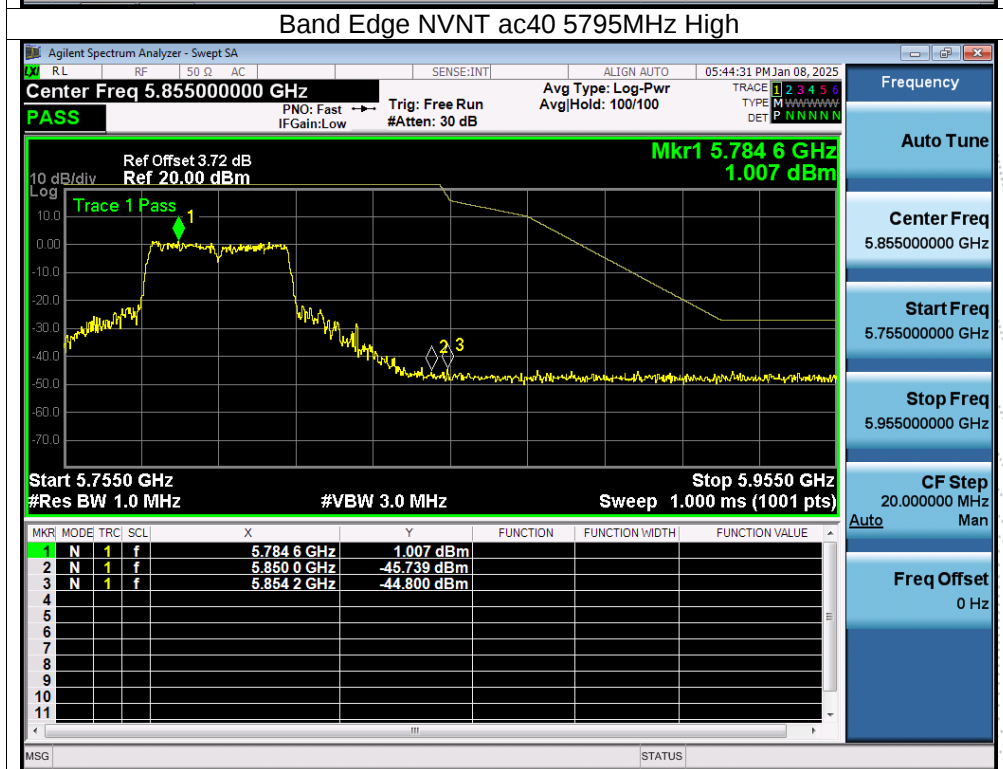
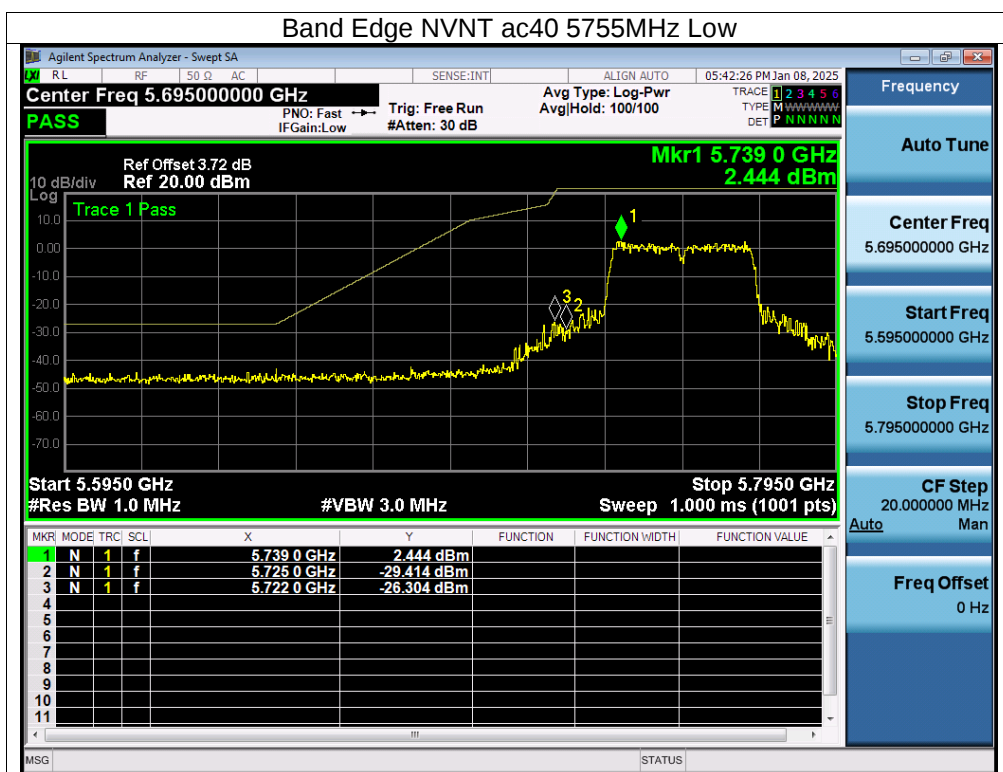
Band Edge NVNT a 5825MHz High

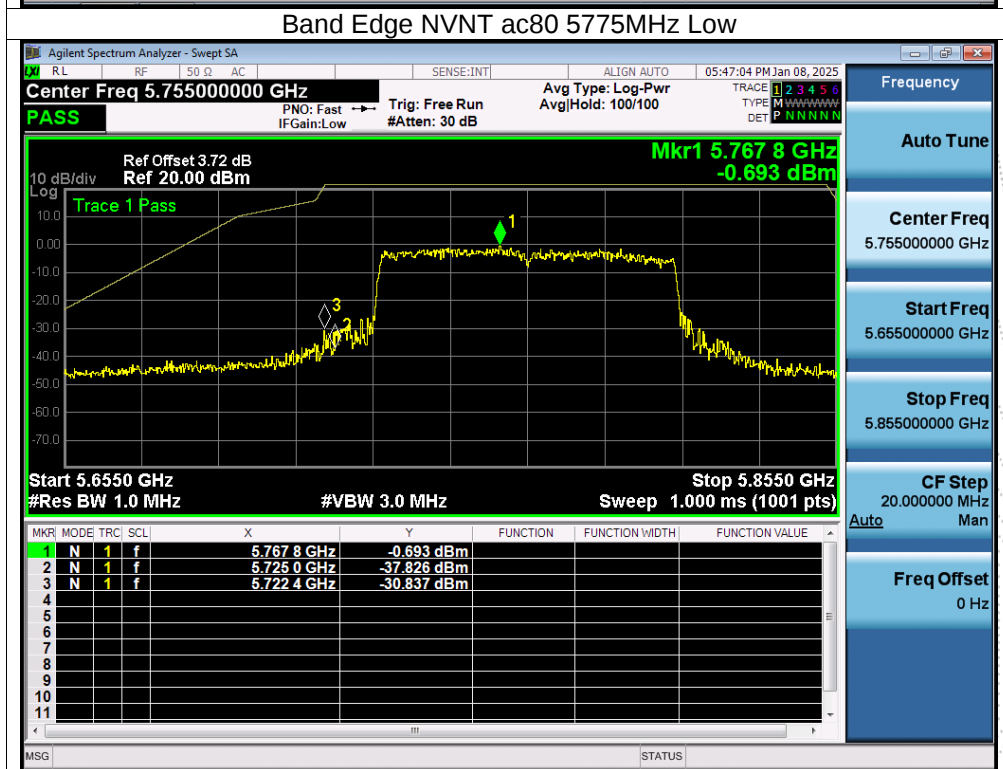
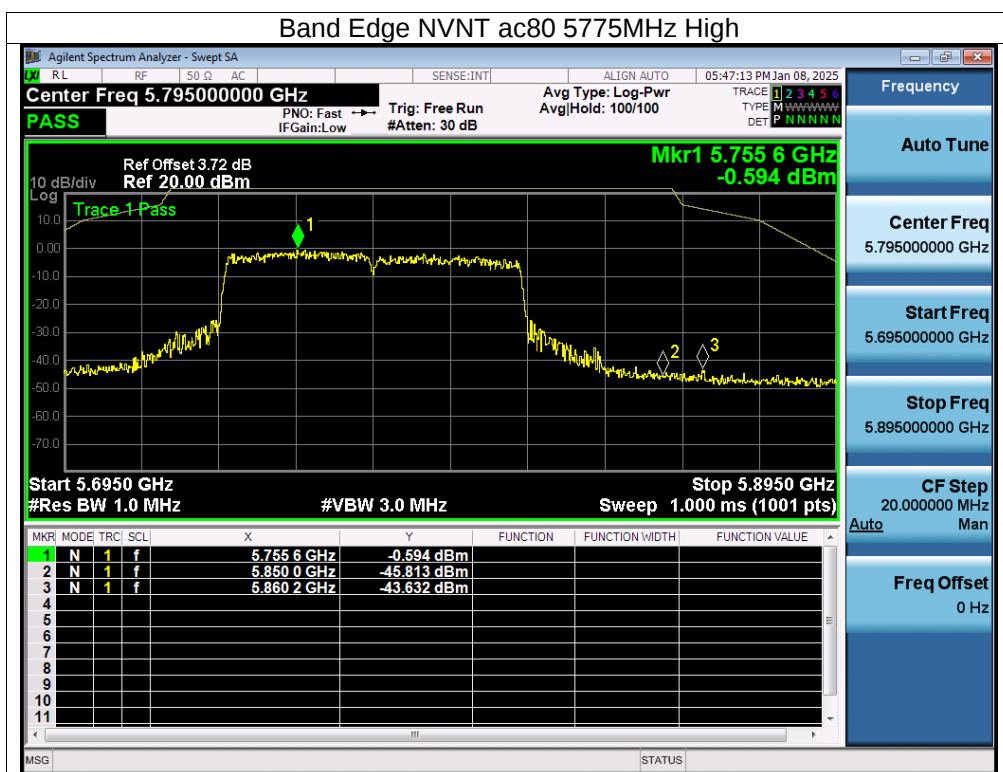












12. Spurious RF Conducted Emissions

12.1 Block Diagram Of Test Setup



12.2 Limit

Undesirable emission limits. Except as shown in paragraph (b)(7) of this section, the maximum emissions outside of the frequency bands of operation shall be attenuated in accordance with the following limits:

(1) For transmitters operating in the 5.15-5.25 GHz band: All emissions outside of the 5.15-5.35 GHz band shall not exceed an e.i.r.p. of -27 dBm/MHz.

(2) For transmitters operating in the 5.725-5.85 GHz band(i) All emissions shall be limited to a level of -27 dBm/MHz at 75 MHz or more above or below the band edge increasing linearly to 10 dBm/MHz at 25 MHz above or below the band edge, and from 25 MHz above or below the band edge increasing linearly to a level of 15.6 dBm/MHz at 5 MHz above or below the band edge, and from 5 MHz above or below the band edge increasing linearly to a level of 27 dBm/MHz at the band edge..

12.3 Test Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable. Then set it to any one measured frequency within its operating range, and make sure the instrument is operated in its linear range.
3. Set RBW of spectrum analyzer to 1 MHz with a convenient frequency span.
4. Measure the highest amplitude appearing on spectral display and set it as a reference level. Plot the graph with marking the highest point and edge frequency.
5. Repeat above procedures until all measured frequencies were complete.

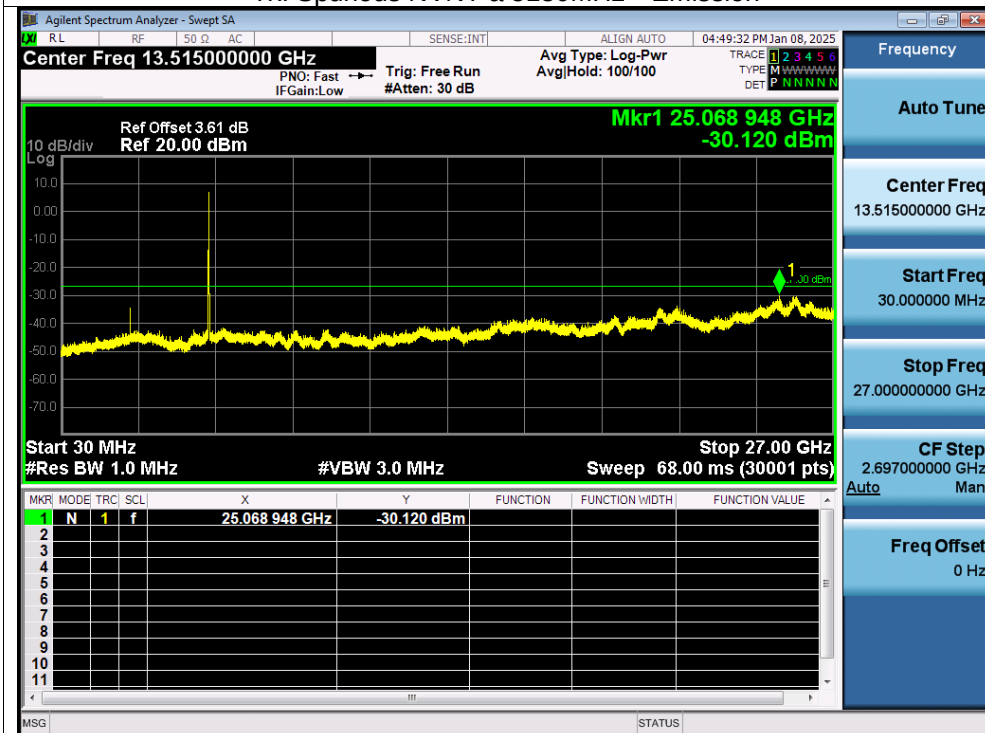
12.4 Test Result

Remark: The measurement frequency range is from 9KHz to the 10th harmonic of the fundamental frequency. The lowest, middle and highest channels are tested to verify the spurious emissions and band edge measurement data.

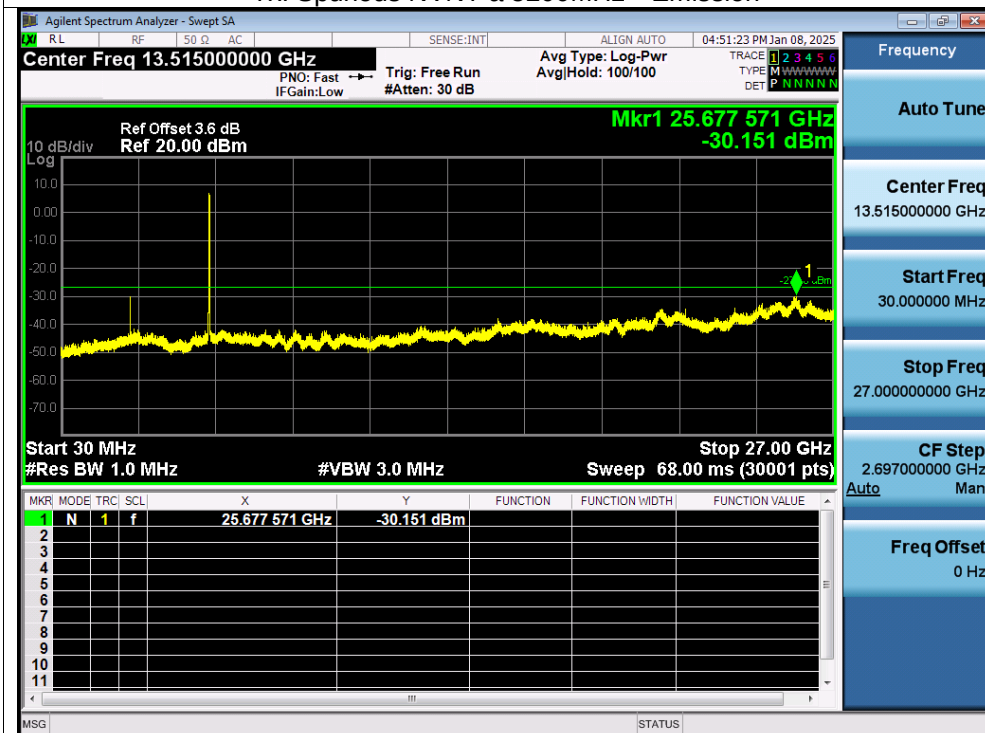
About: 26.5GHz-40GHz, The amplitude of spurious emissions which are attenuated by more than 20dB below the permissible value has no need to be reported.

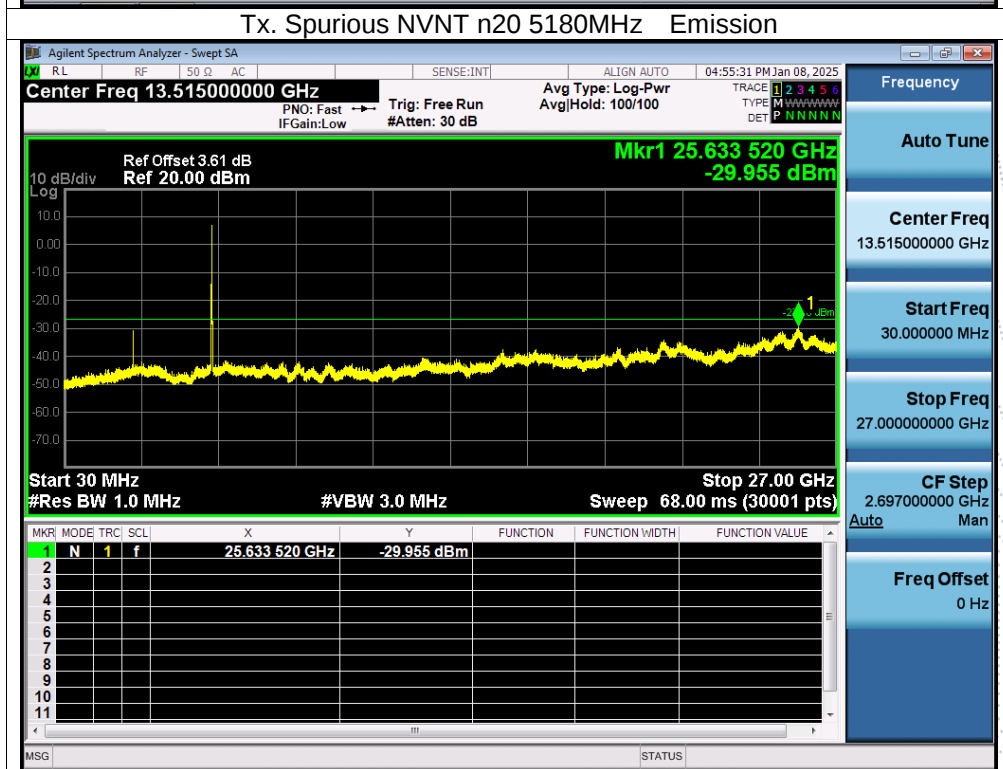
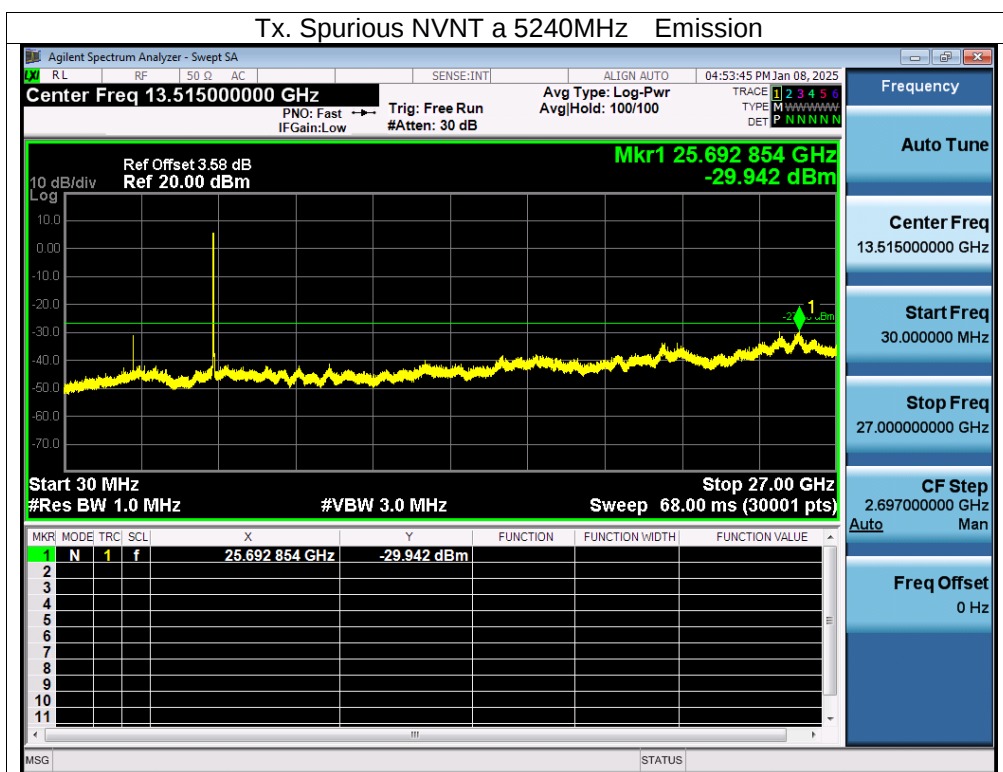
Test Graphs

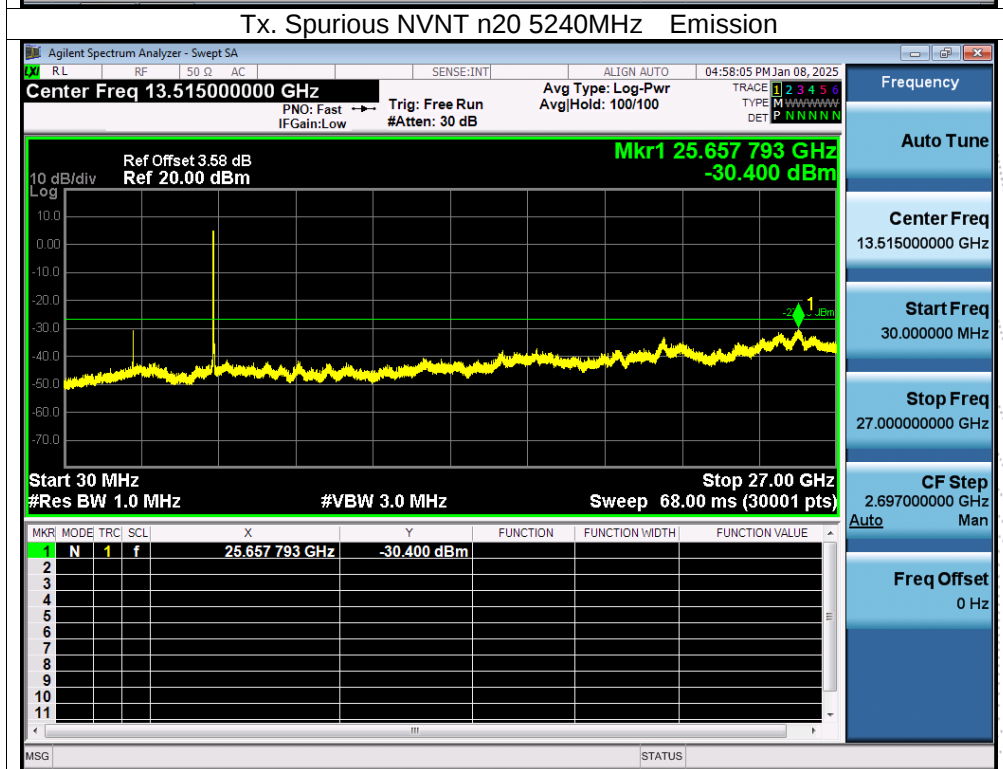
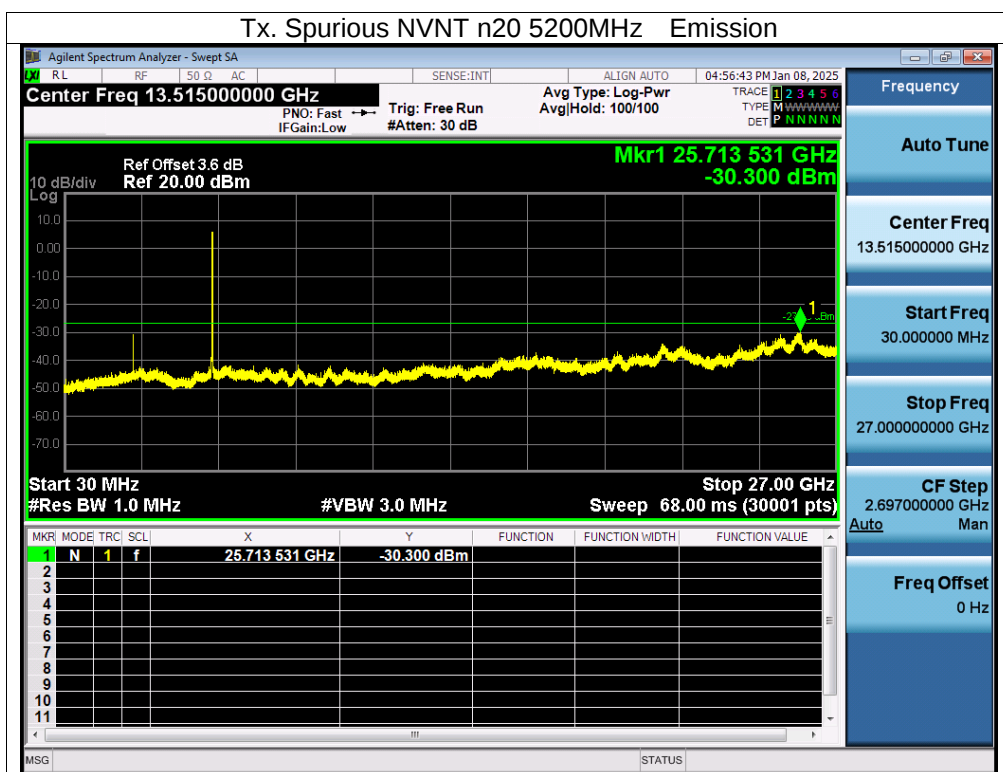
Tx. Spurious NVNT a 5180MHz Emission

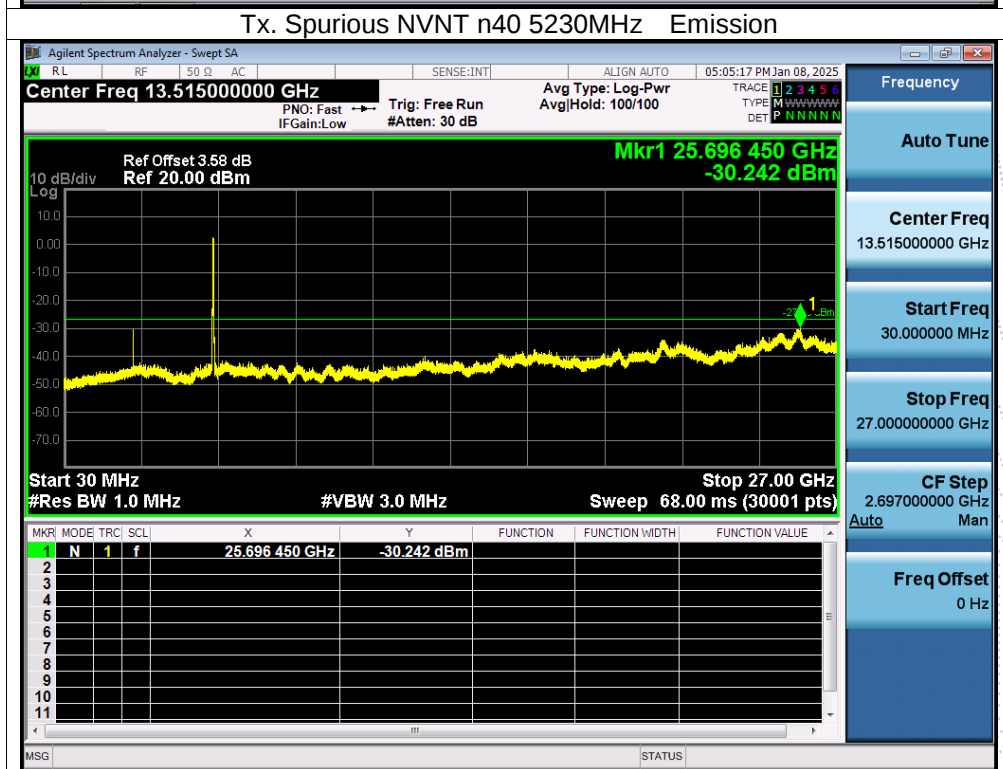
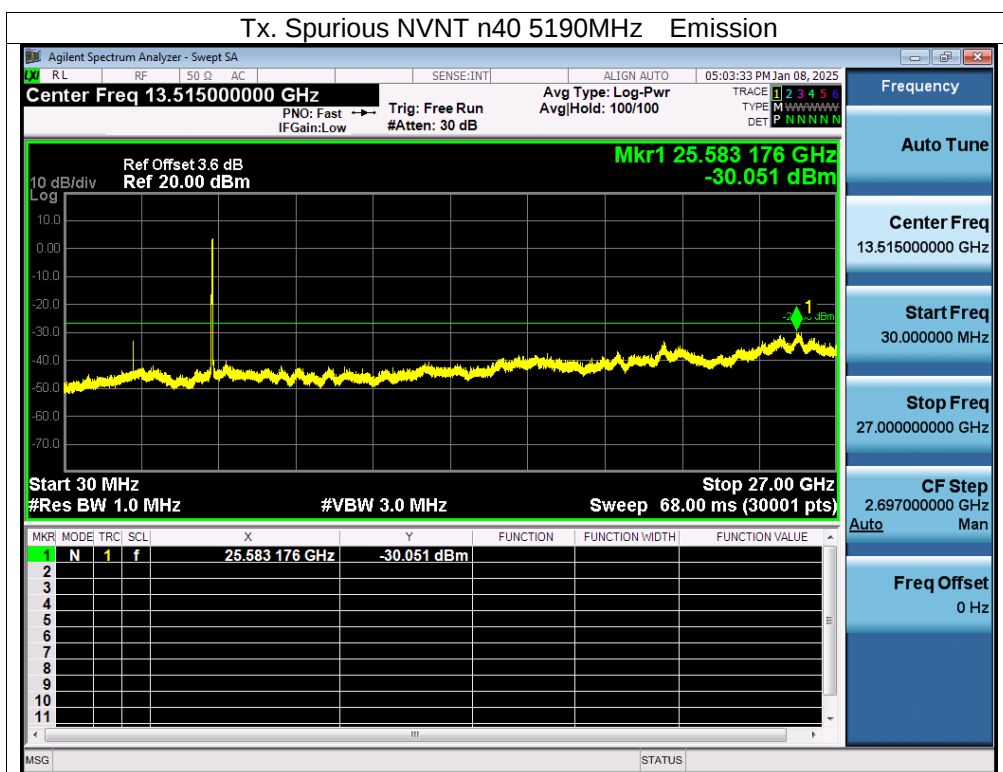


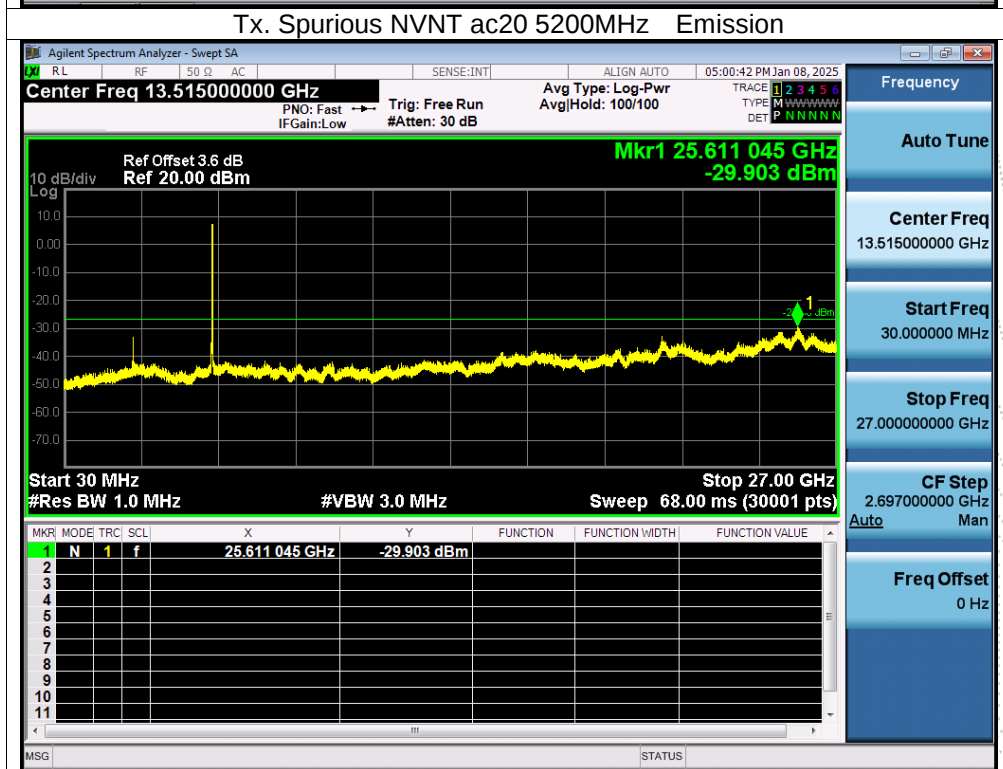
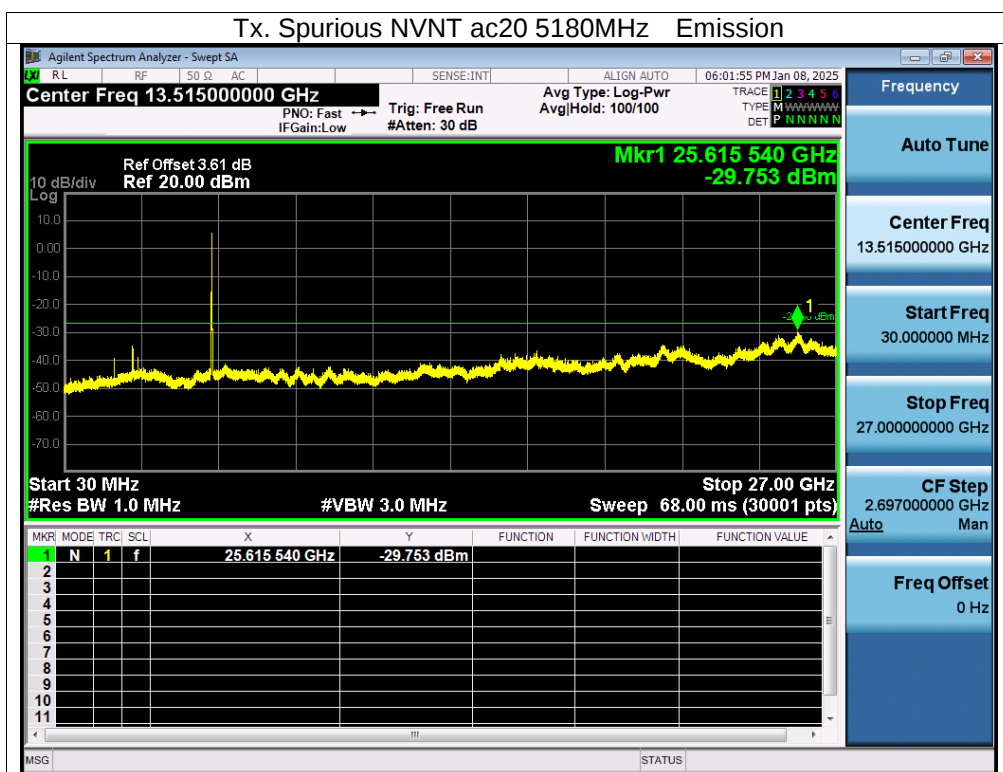
Tx. Spurious NVNT a 5200MHz Emission

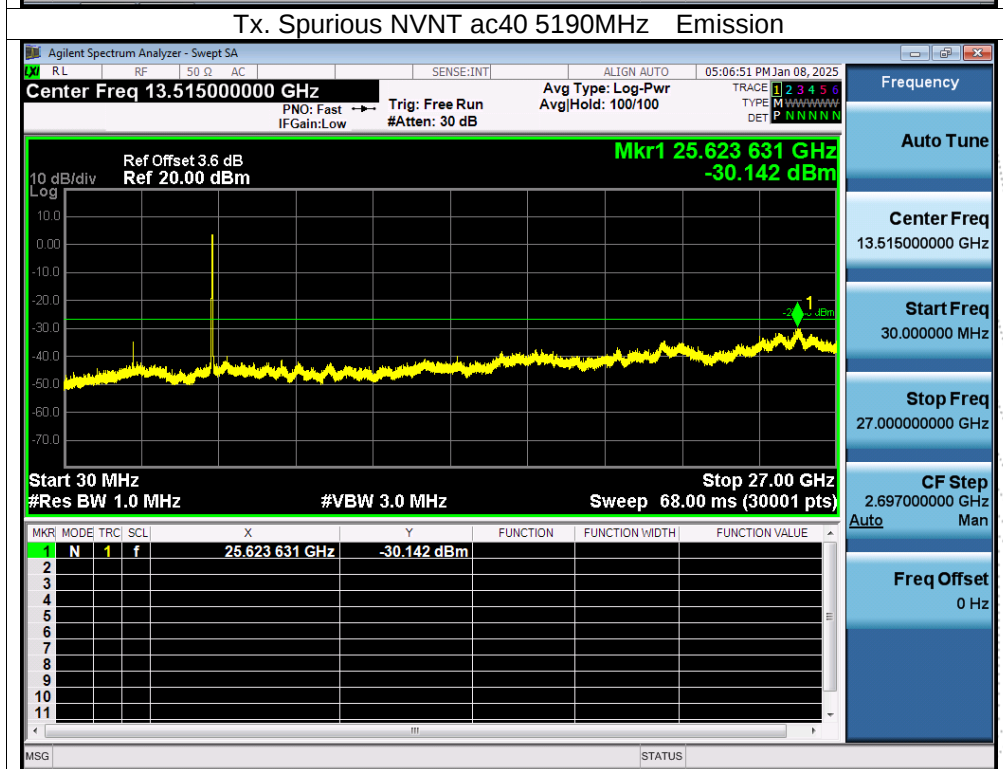
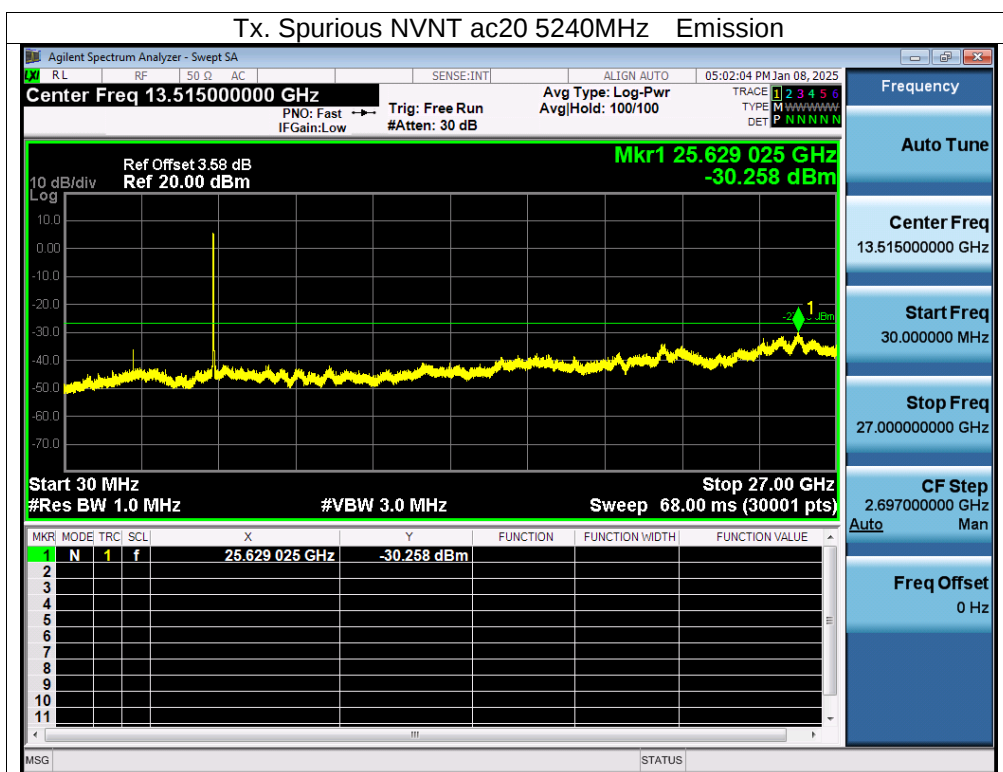


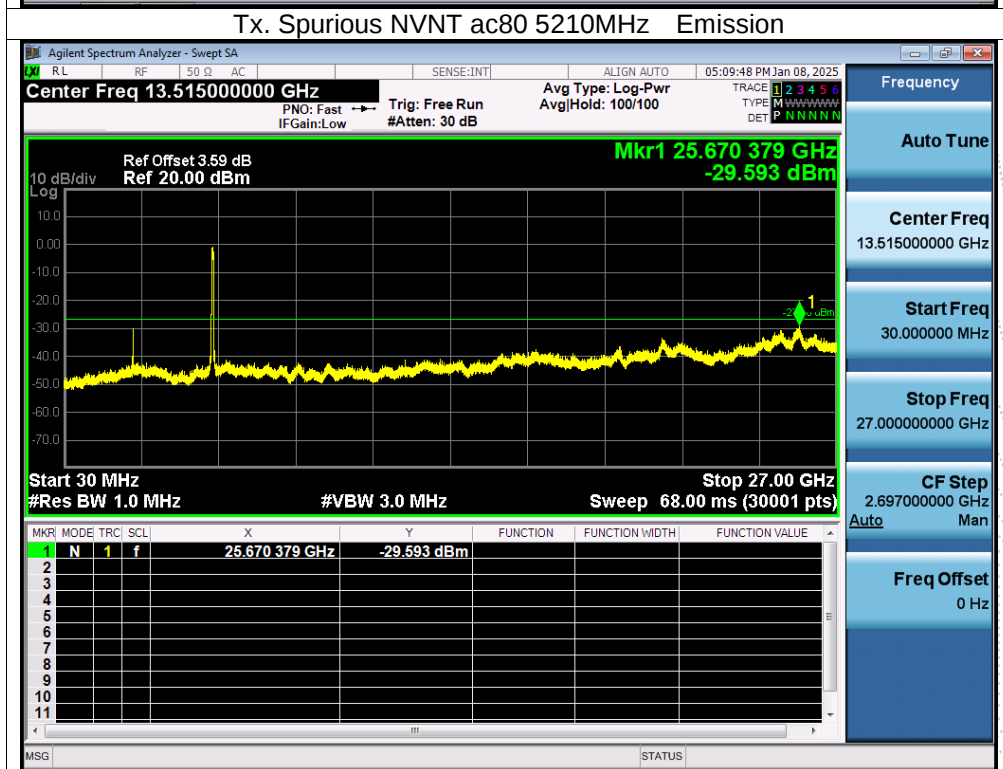
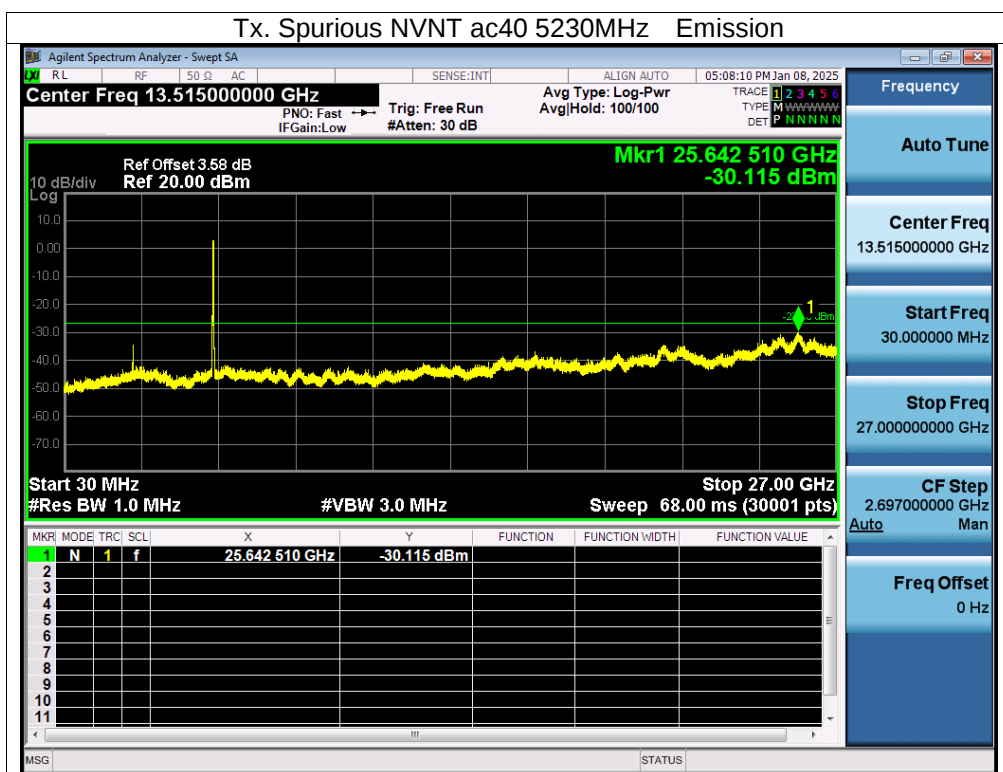






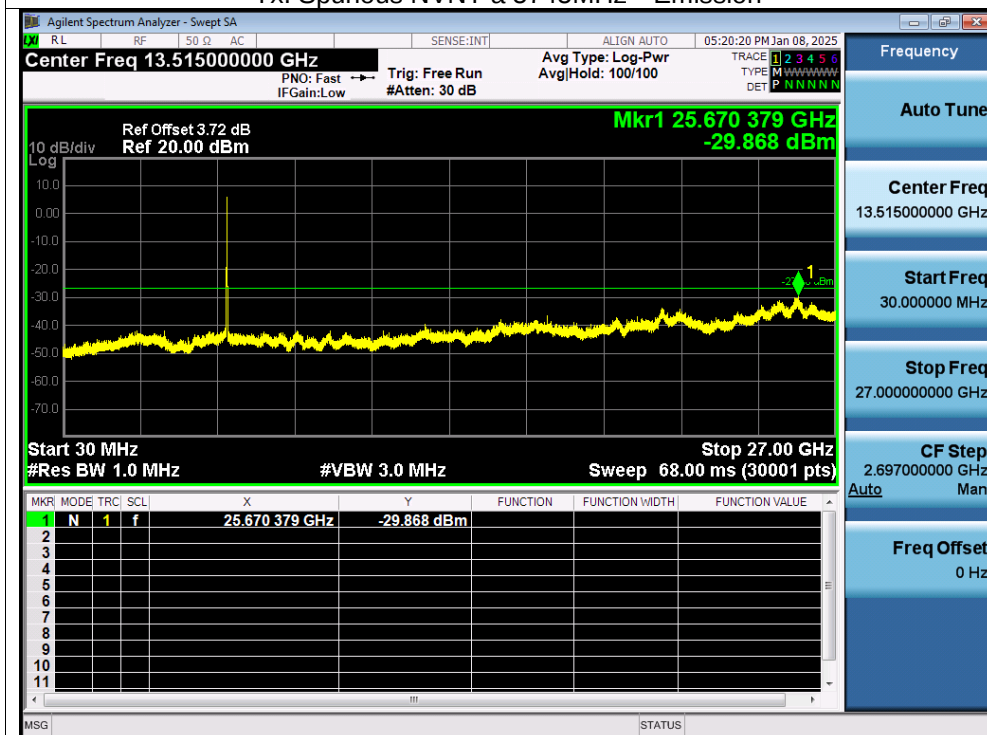




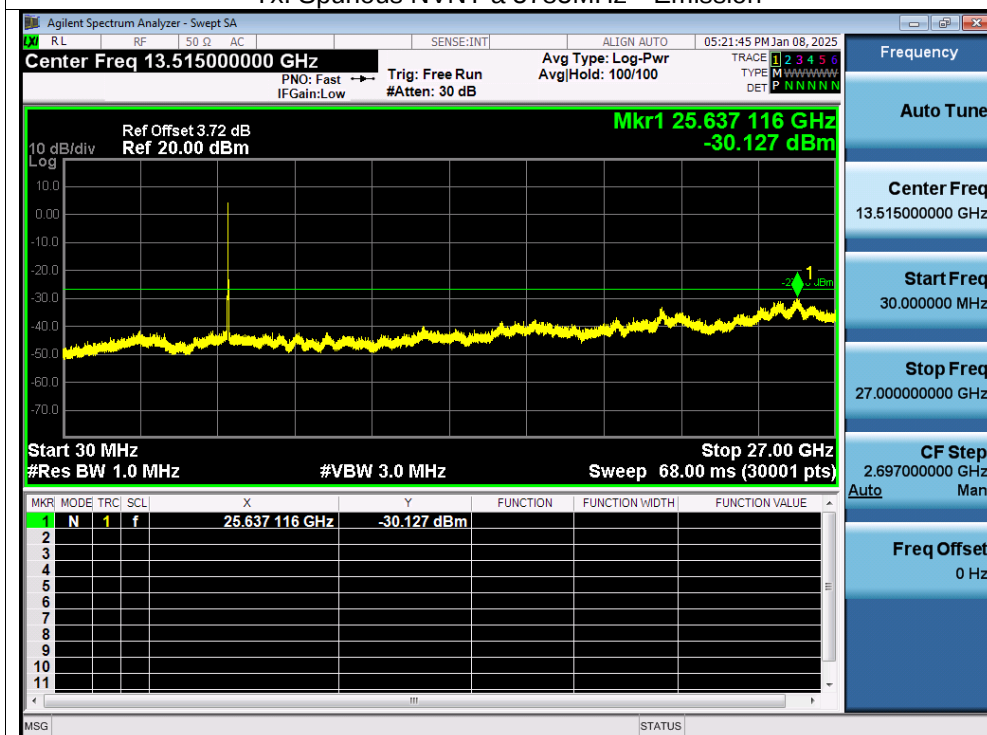


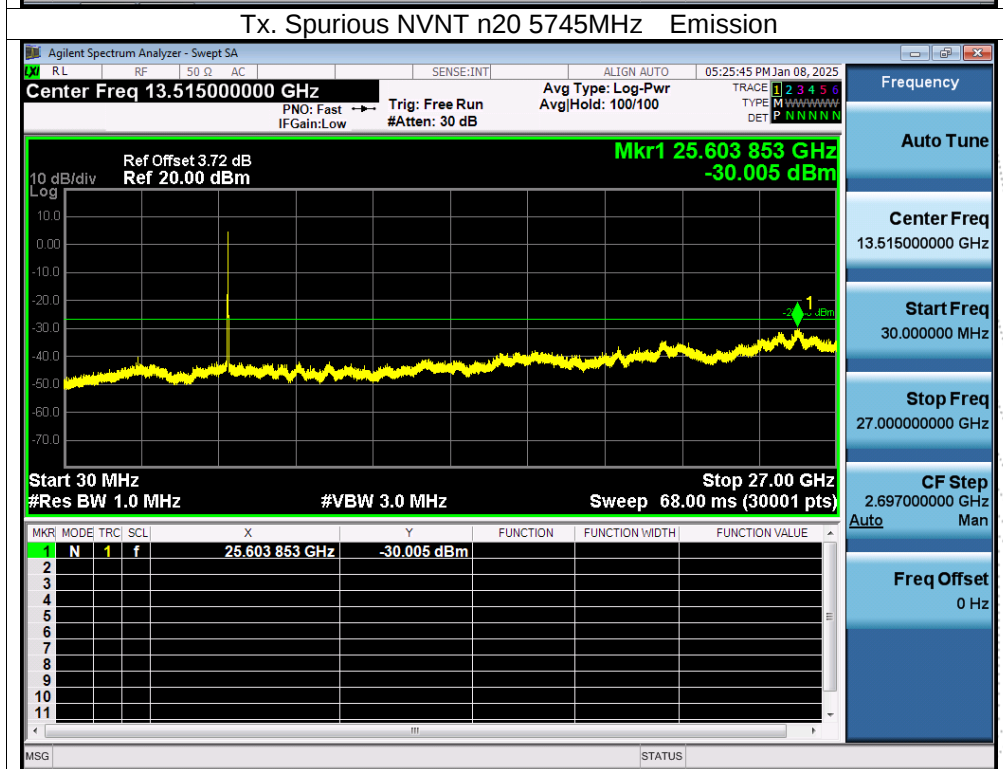
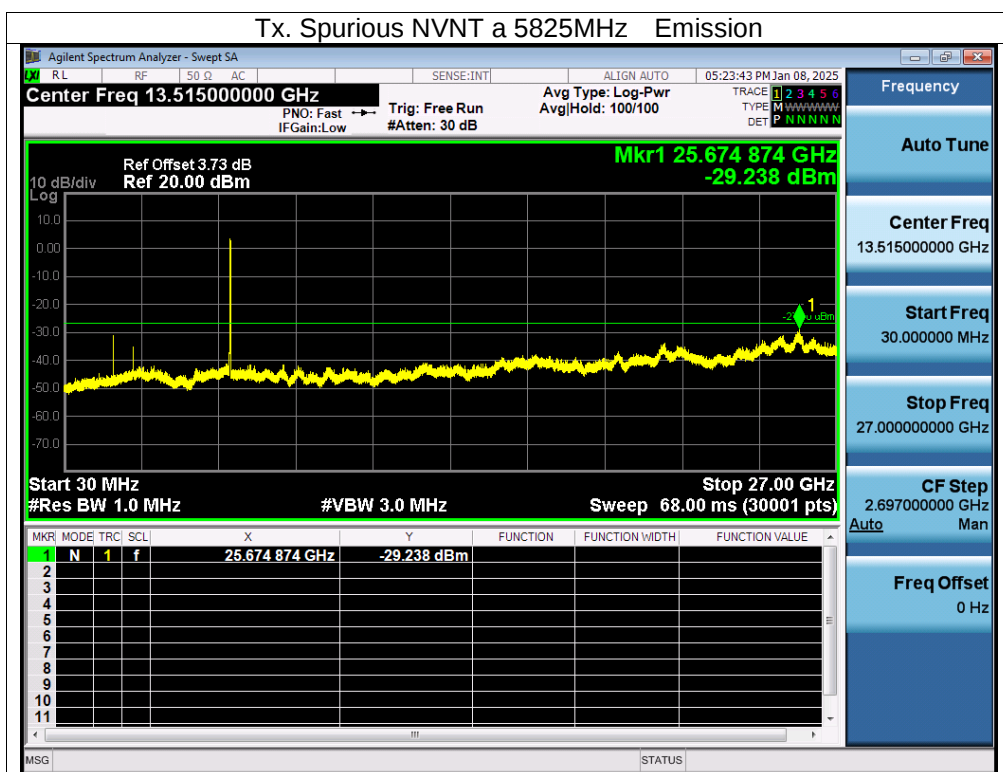
Test Graphs

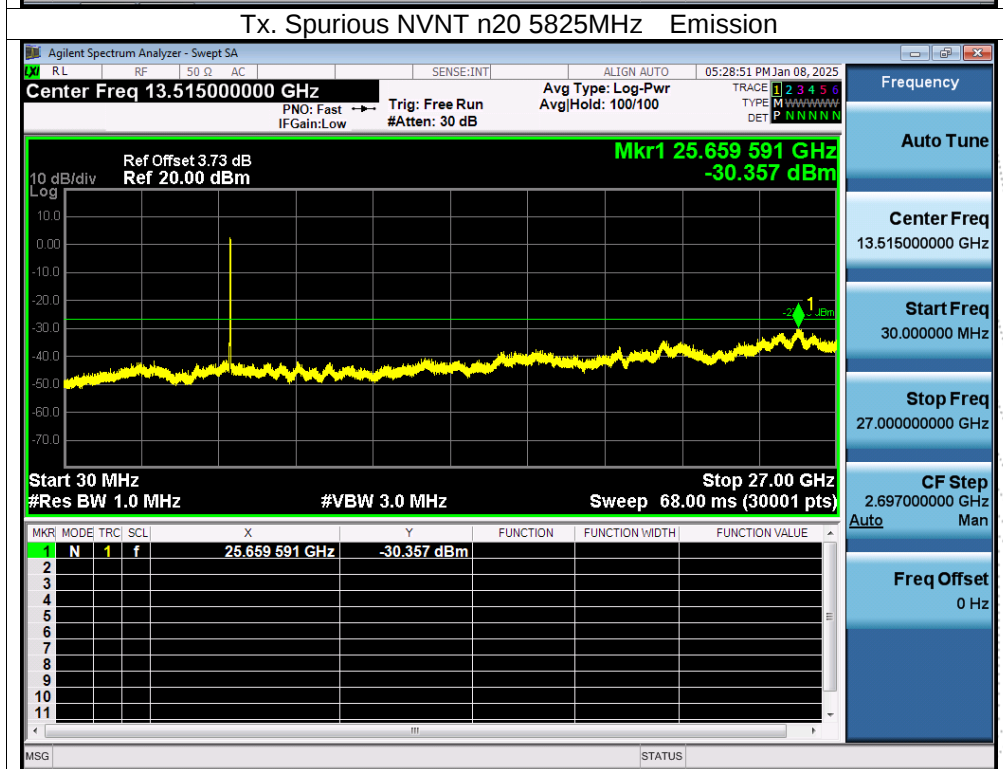
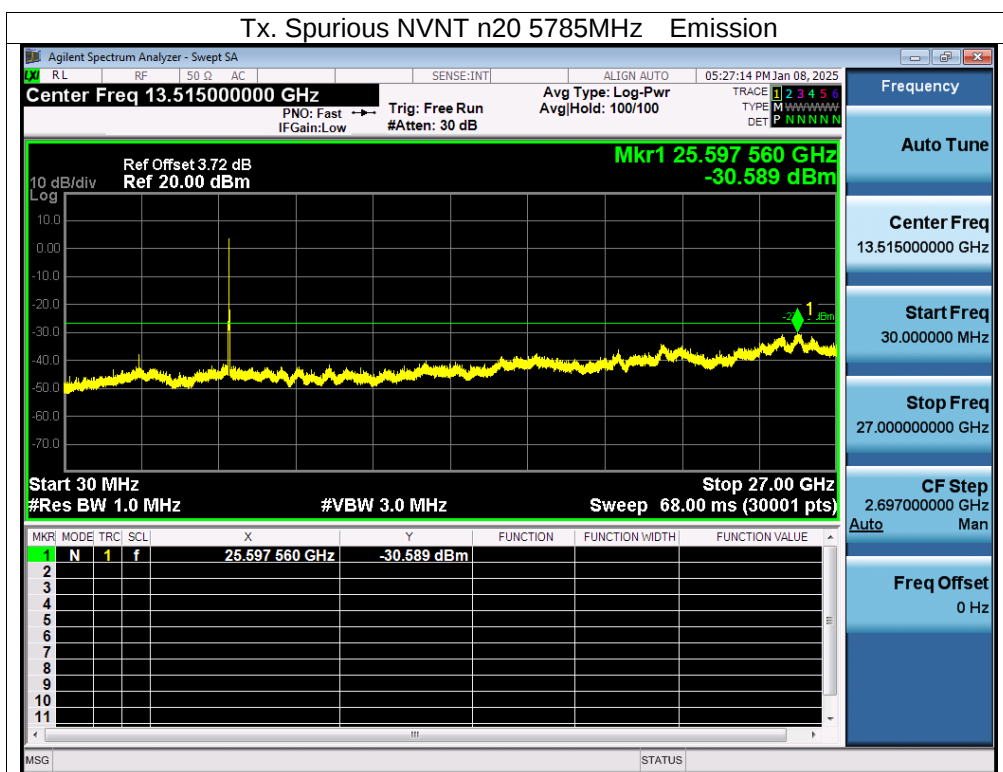
Tx. Spurious NVNT a 5745MHz Emission

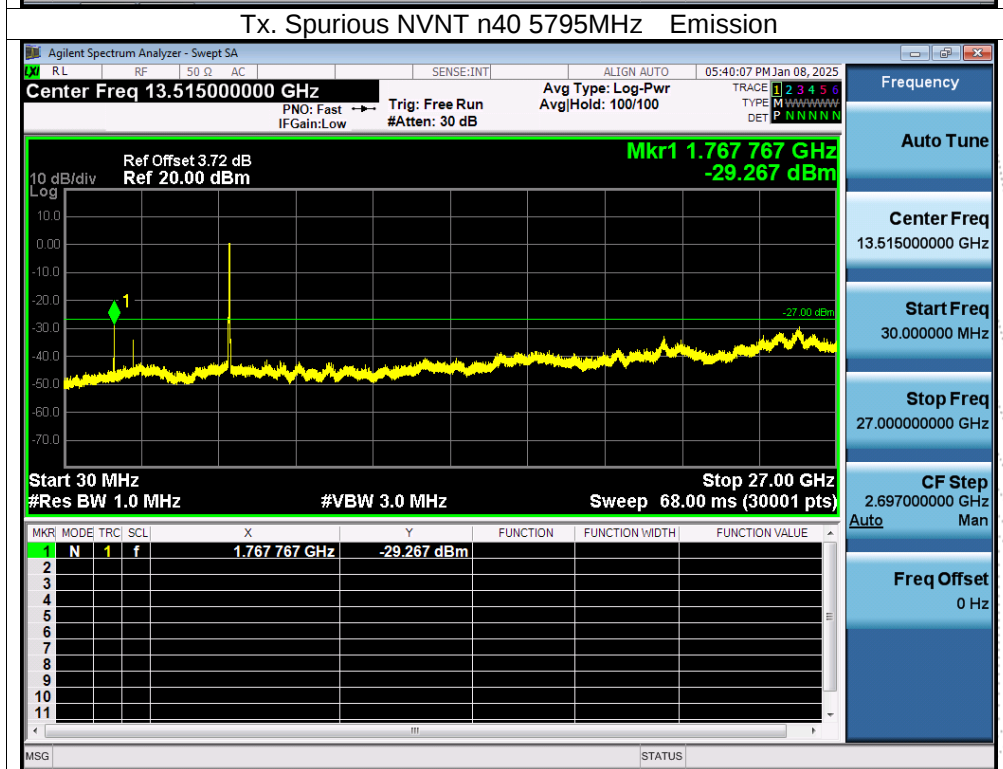
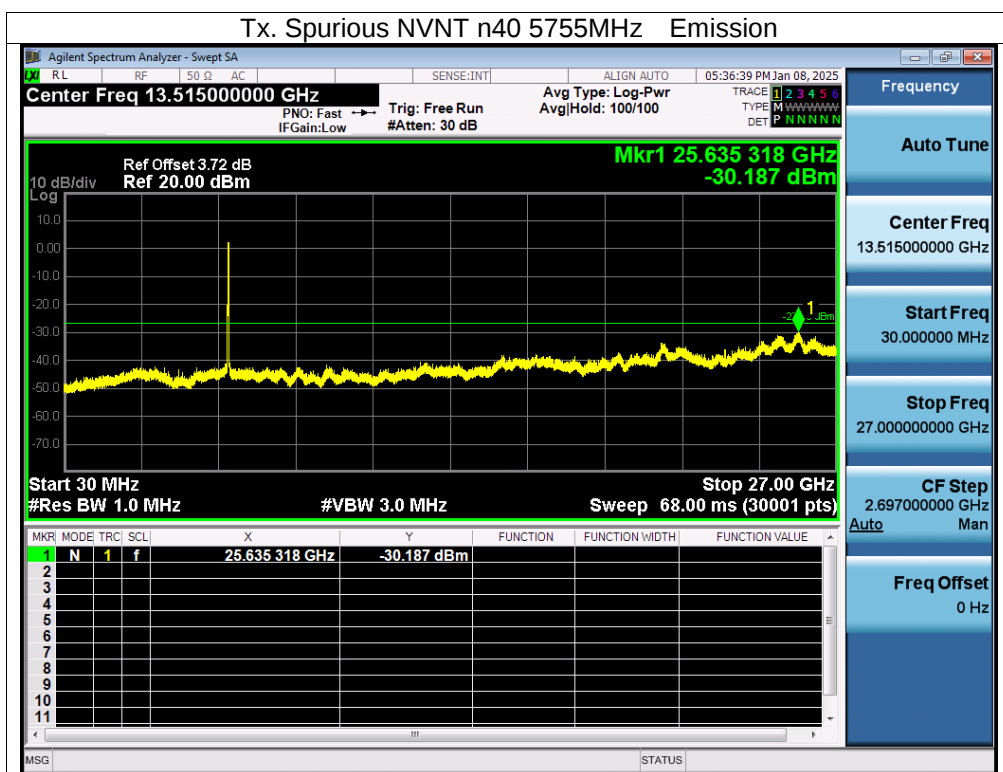


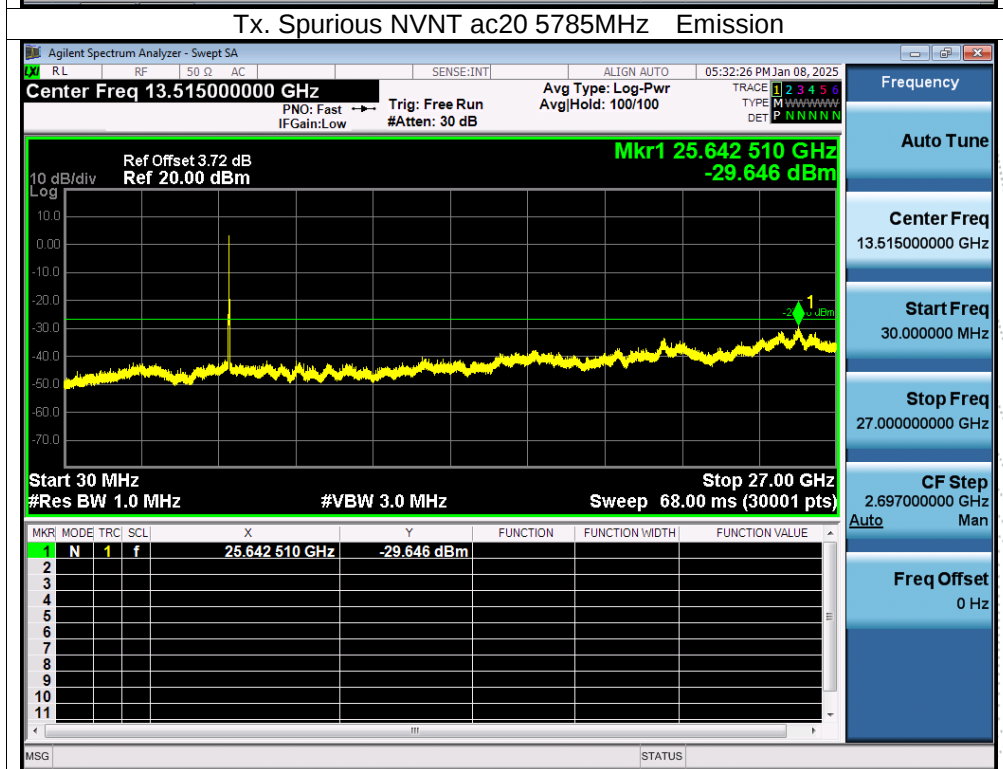
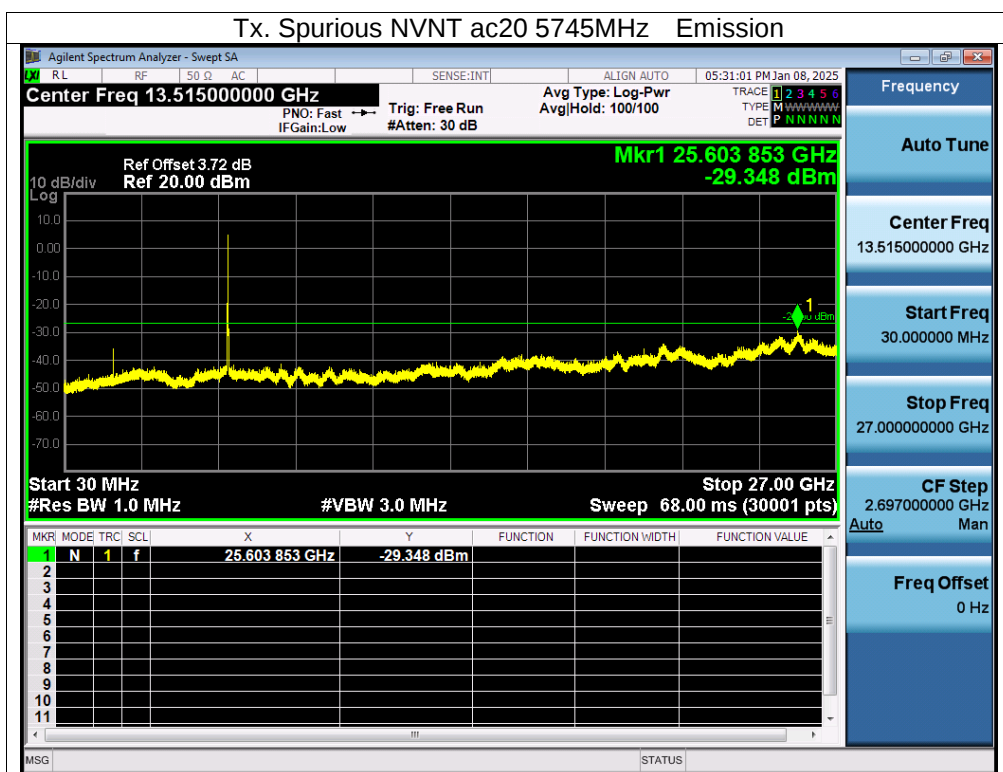
Tx. Spurious NVNT a 5785MHz Emission

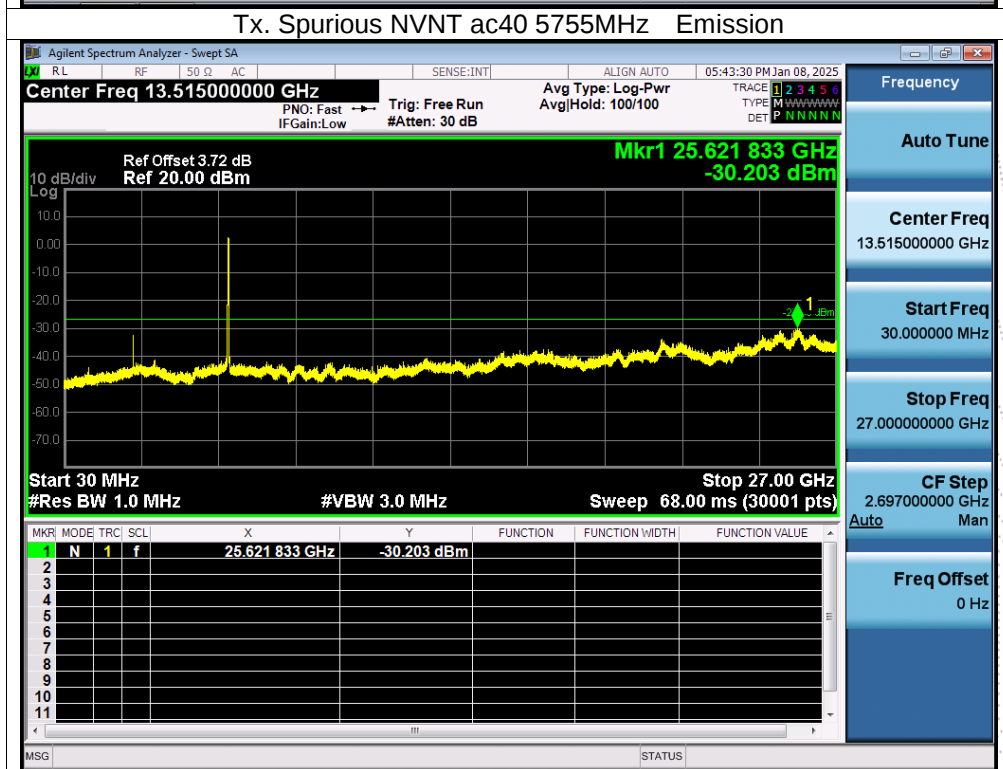
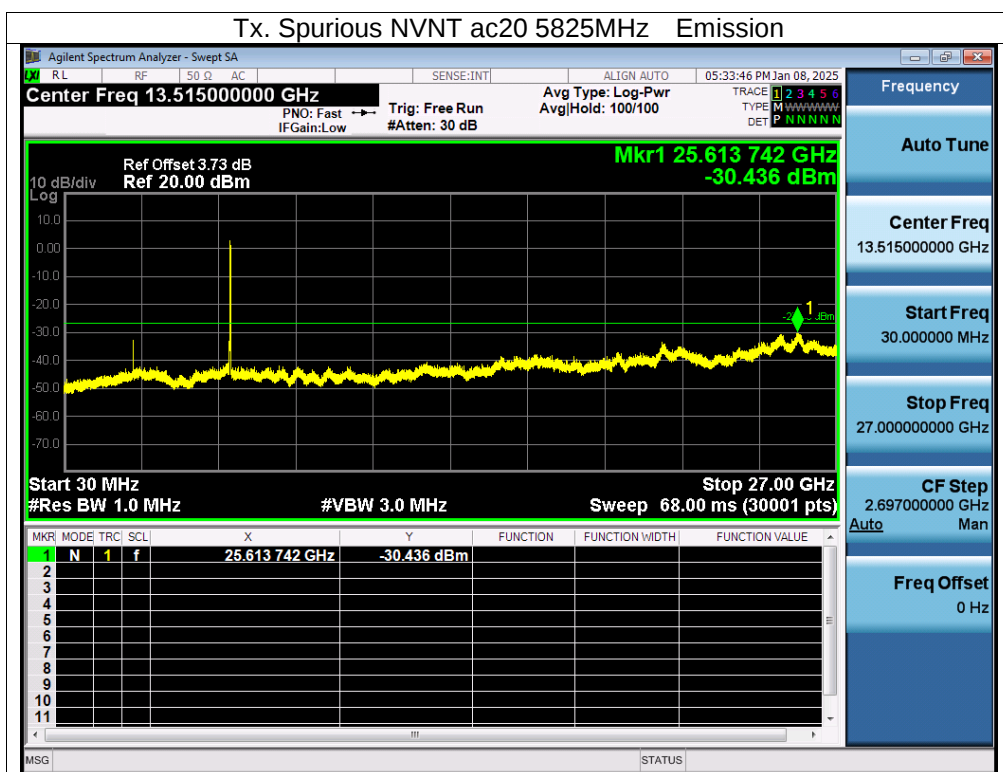


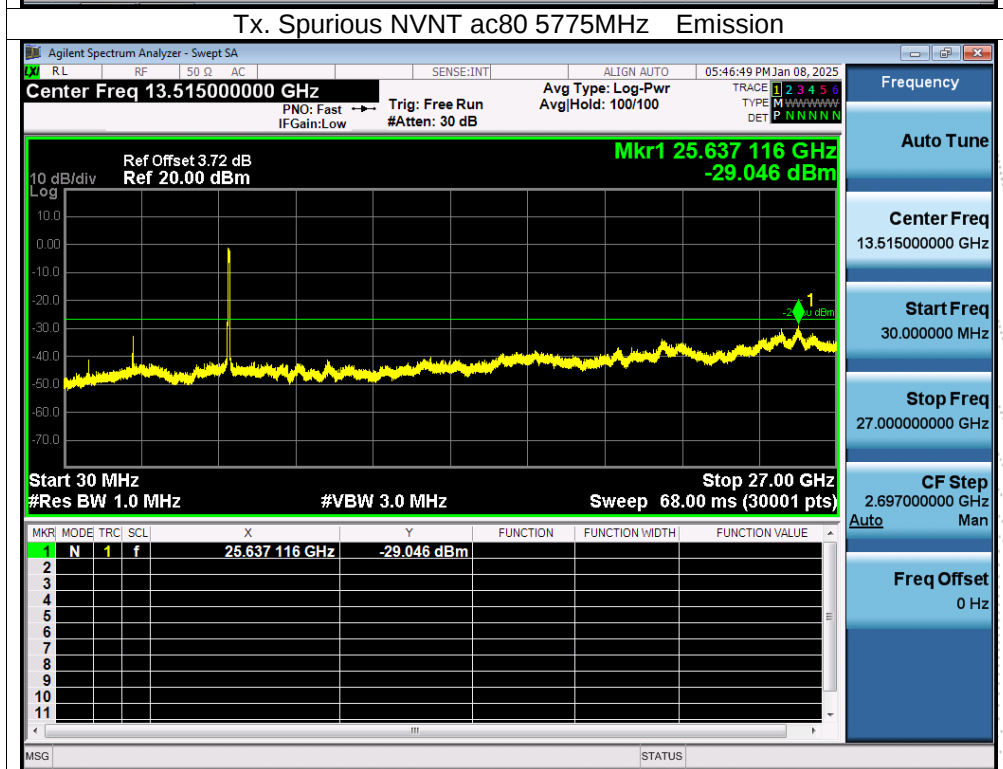
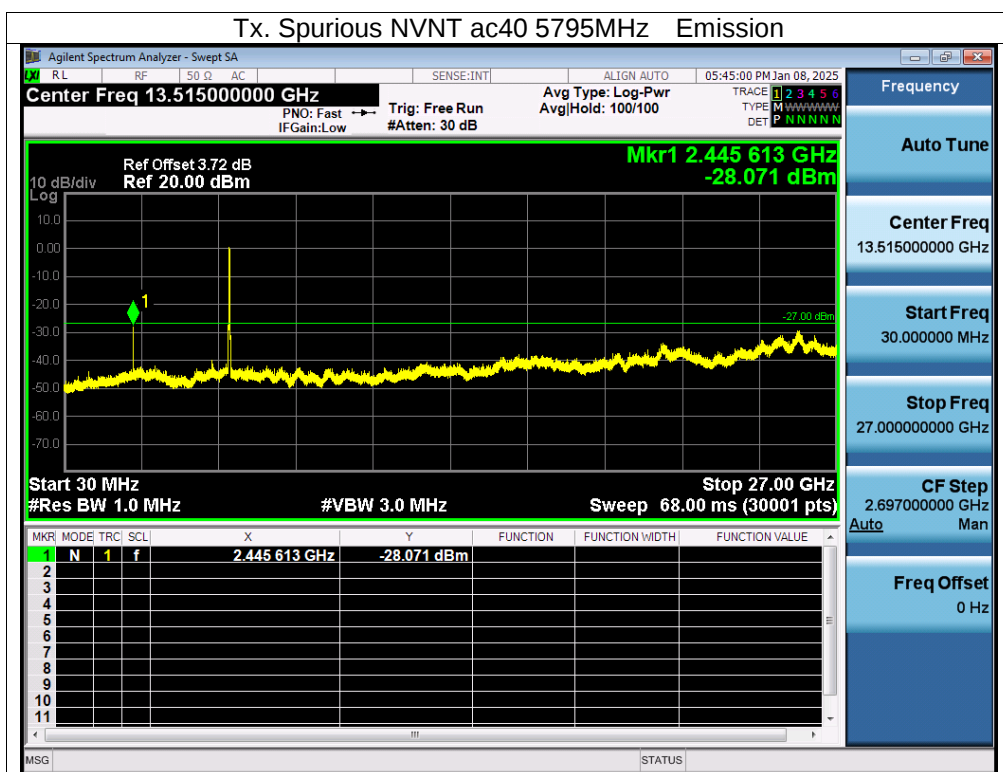












13. Frequency Stability Measurement

13.1 Block Diagram Of Test Setup



13.2 Limit

Manufactures of U-NII devices are responsible for ensuring frequency stability such that an emission is maintained within the band of operation under all conditions of normal operation as specified in the user's manual.

The transmitter center frequency tolerance shall be ± 20 ppm maximum for the 5 GHz band (IEEE 802.11n specification)..

13.3 Test Procedure

1. The transmitter output (antenna port) was connected to the spectrum analyzer.
2. EUT have transmitted absence of modulation signal and fixed channelize.
3. Set the spectrum analyzer span to view the entire absence of modulation emissions bandwidth.
4. Set RBW = 10 kHz, VBW = 10 kHz with peak detector and maxhold settings.
5. f_c is declaring of channel frequency. Then the frequency error formula is $(f_c - f)/f_c \times 10^6$ ppm and he limit is less than ± 20 ppm (IEEE 802.11n specification).
6. The test extreme voltage is to change the primary supply voltage from 85 to 115 percent of the nominal value
7. Extreme temperature is $-20^\circ\text{C} \sim 70^\circ\text{C}$.

13.4 Test Result

Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101kPa	Test Voltage:	DC 3.9V
Test Mode:	TX Frequency U-NII-1 (5180-5240MHz)		

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency : 5180MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.90	5180.0005	5180	0.0005	0.0965
		V max (V)	4.49	5180.0098	5180	0.0098	1.8919
		V min (V)	3.32	5180.0102	5180	0.0102	1.9691
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5180MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.9	T (°C)	-20	5180.0013	5180	0.0013	0.2510
		T (°C)	-10	5180.0015	5180	0.0015	0.2896
		T (°C)	0	5180.0091	5180	0.0091	1.7568
		T (°C)	10	5180.0124	5180	0.0124	2.3938
		T (°C)	20	5180.0020	5180	0.0020	0.3861
		T (°C)	30	5180.0071	5180	0.0071	1.3707
		T (°C)	40	5180.0135	5180	0.0135	2.6062
		T (°C)	50	5180.0084	5180	0.0084	1.6216
		T (°C)	60	5180.0106	5180	0.0106	2.0463
		T (°C)	70	5180.0003	5180	0.0003	0.0579
Limits				5150-5250 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5200MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.90	5200.0059	5200	0.0059	1.1346
		V max (V)	4.49	5200.0106	5200	0.0106	2.0385
		V min (V)	3.32	5200.0007	5200	0.0007	0.1346
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5200MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.9	T (°C)	-20	5200.00700	5200	0.00700	1.3462
		T (°C)	-10	5200.00460	5200	0.00460	0.8846
		T (°C)	0	5200.00620	5200	0.00620	1.1923
		T (°C)	10	5200.00310	5200	0.00310	0.5962
		T (°C)	20	5200.01090	5200	0.01090	2.0962
		T (°C)	30	5200.00860	5200	0.00860	1.6538
		T (°C)	40	5200.00660	5200	0.00660	1.2692
		T (°C)	50	5200.00620	5200	0.00620	1.1923
		T (°C)	60	5200.01070	5200	0.01070	2.0577
		T (°C)	70	5200.01150	5200	0.01150	2.2115
Limits				5150-5250 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5240MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.90	5240.0075	5240	0.0075	1.4313
		V max (V)	4.49	5240.0012	5240	0.0012	0.2290
		V min (V)	3.32	5240.0043	5240	0.0043	0.8206
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5240MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.9	T (°C)	-20	5240.0004	5240	0.0004	0.0763
		T (°C)	-10	5240.0032	5240	0.0032	0.6107
		T (°C)	0	5240.0001	5240	0.0001	0.0191
		T (°C)	10	5240.0072	5240	0.0072	1.3740
		T (°C)	20	5240.0033	5240	0.0033	0.6298
		T (°C)	30	5240.0062	5240	0.0062	1.1832
		T (°C)	40	5240.0045	5240	0.0045	0.8588
		T (°C)	50	5240.0109	5240	0.0109	2.0802
		T (°C)	60	5240.0051	5240	0.0051	0.9733
		T (°C)	70	5240.0060	5240	0.0060	1.1450
Limits				5150-5250 MHz			
Result				Complies			

Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101kPa	Test Voltage:	DC 3.9V
Test Mode:	TX Frequency(5745-5825MHz)		

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5745MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.90	5745.01240	5745	0.01240	2.1584
		V max (V)	4.49	5745.01190	5745	0.01190	2.0714
		V min (V)	3.32	5745.00270	5745	0.00270	0.4700
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5745MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.9	T (°C)	-20	5745.00050	5745	0.00050	0.0870
		T (°C)	-10	5745.01250	5745	0.01250	2.1758
		T (°C)	0	5745.00850	5745	0.00850	1.4795
		T (°C)	10	5745.00550	5745	0.00550	0.9574
		T (°C)	20	5745.01240	5745	0.01240	2.1584
		T (°C)	30	5745.00540	5745	0.00540	0.9399
		T (°C)	40	5745.01080	5745	0.01080	1.8799
		T (°C)	50	5745.00250	5745	0.00250	0.4352
		T (°C)	60	5745.00250	5745	0.00250	0.4352
		T (°C)	70	5745.01340	5745	0.01340	2.3325
Limits				5725-5850 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5785MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.90	5785.00440	5785	0.00440	0.7606
		V max (V)	4.49	5785.00260	5785	0.00260	0.4494
		V min (V)	3.32	5785.00460	5785	0.00460	0.7952
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5785MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.9	T (°C)	-20	5785.00030	5785	0.00030	0.0519
		T (°C)	-10	5785.00540	5785	0.00540	0.9334
		T (°C)	0	5785.01330	5785	0.01330	2.2990
		T (°C)	10	5785.00250	5785	0.00250	0.4322
		T (°C)	20	5785.01330	5785	0.01330	2.2990
		T (°C)	30	5785.00230	5785	0.00230	0.3976
		T (°C)	40	5785.00130	5785	0.00130	0.2247
		T (°C)	50	5785.00580	5785	0.00580	1.0026
		T (°C)	60	5785.00300	5785	0.00300	0.5186
		T (°C)	70	5785.00560	5785	0.00560	0.9680
Limits				5725-5850 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5825MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	3.90	5825.01020	5825	0.01020	1.7511
		V max (V)	4.49	5825.00100	5825	0.00100	0.1717
		V min (V)	3.32	5825.00520	5825	0.00520	0.8927
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5825MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	3.9	T (°C)	-20	5825.00030	5825	0.00030	0.0515
		T (°C)	-10	5825.01050	5825	0.01050	1.8026
		T (°C)	0	5825.00880	5825	0.00880	1.5107
		T (°C)	10	5825.00160	5825	0.00160	0.2747
		T (°C)	20	5825.00780	5825	0.00780	1.3391
		T (°C)	30	5825.01040	5825	0.01040	1.7854
		T (°C)	40	5825.00140	5825	0.00140	0.2403
		T (°C)	50	5825.01220	5825	0.01220	2.0944
		T (°C)	60	5825.00760	5825	0.00760	1.3047
		T (°C)	70	5825.01130	5825	0.01130	1.9399
Limits				5725-5850 MHz			
Result				Complies			

14. Duty Cycle Of Test Signal

14.1 Standard Requirement

Pre-analysis Check: While conducting average power measurement, duty cycle of each mode shall be checked to ensure its duty cycle in order to compensate for the loss due to insufficient ratio of duty cycle. All duty cycle is pre-scanned, and result as obtained below shows only the most representative ones where duty cycle is conducted as the given transmission with given virtual operation that expresses the percentage.

14.2 Formula

Duty Cycle = $T_{on} / (T_{on} + T_{off})$

14.3 Test Procedure

1. Set span = Zero
2. RBW = 8MHz
3. VBW = 8MHz,
4. Detector = Peak

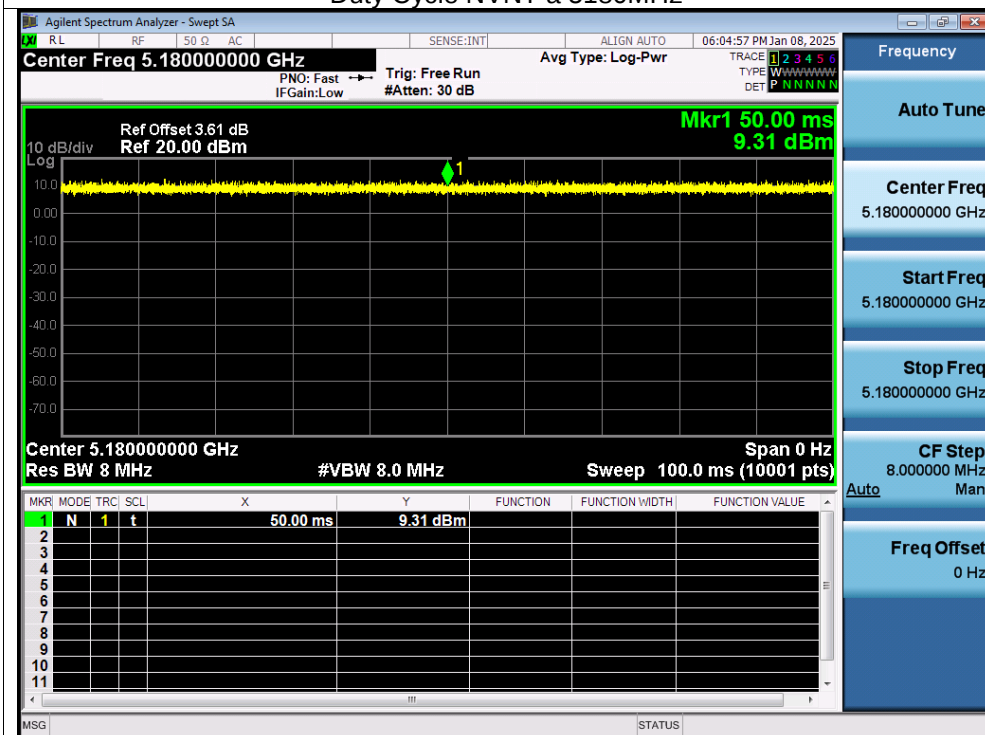
14.4 Test Result

5.1G

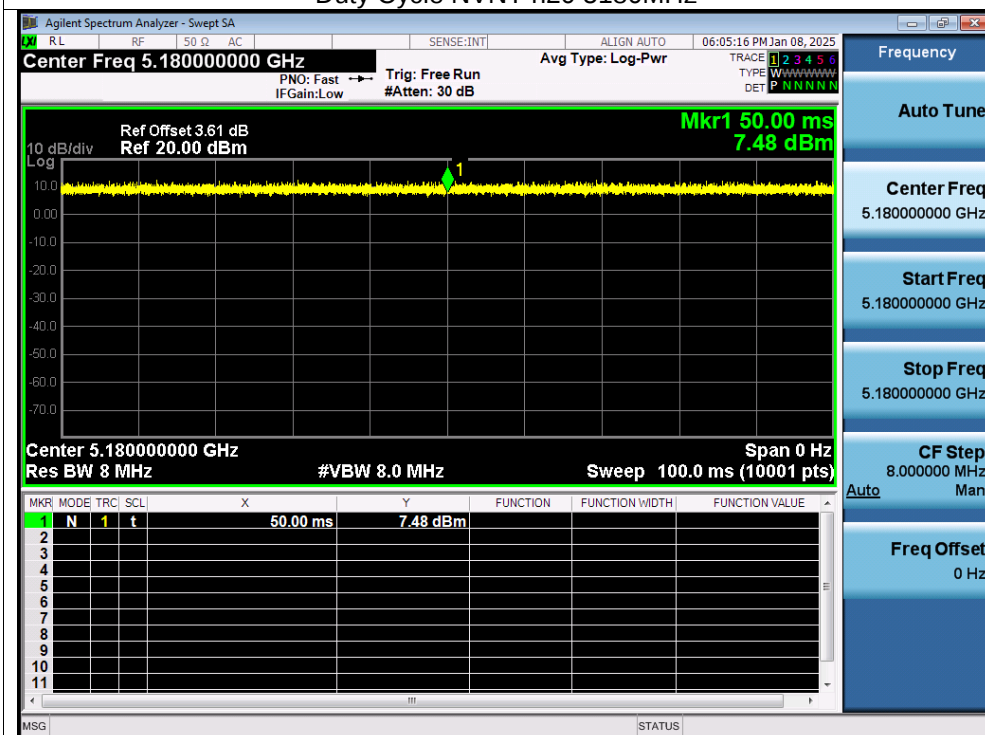
Condition	Mode	Frequency (MHz)	Duty Cycle (%)	Correction Factor (dB)	1/T (kHz)
NVNT	a	5180	100	0	0
NVNT	n20	5180	100	0	0
NVNT	n40	5190	100	0	0
NVNT	ac20	5180	100	0	0
NVNT	ac40	5190	100	0	0
NVNT	ac80	5210	100	0	0

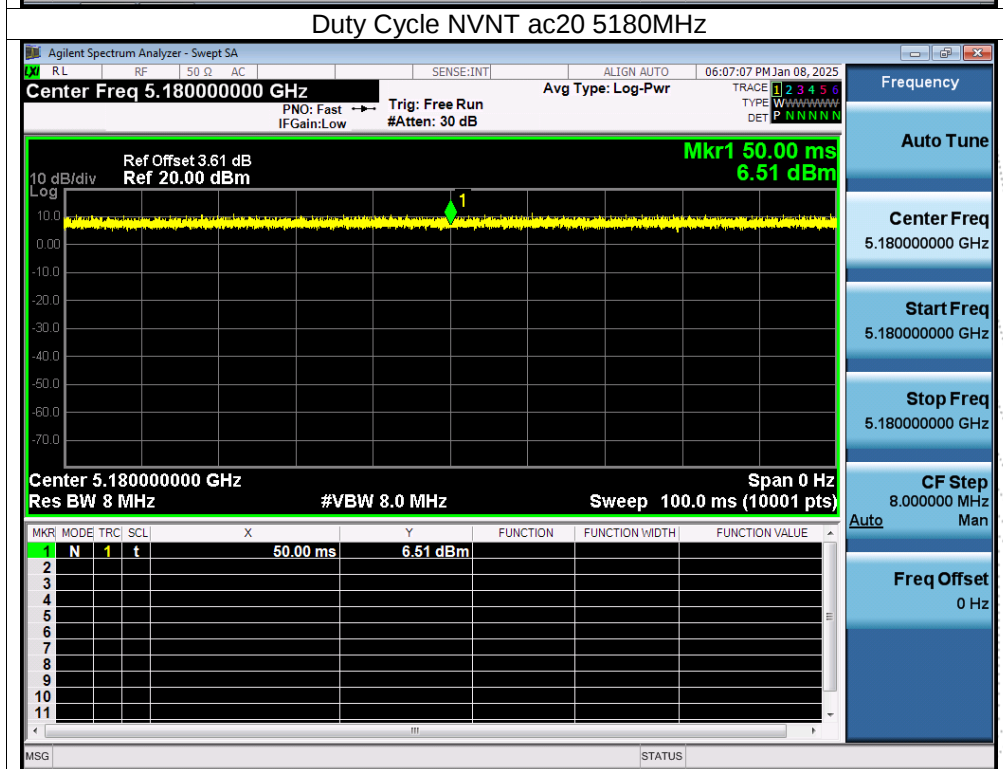
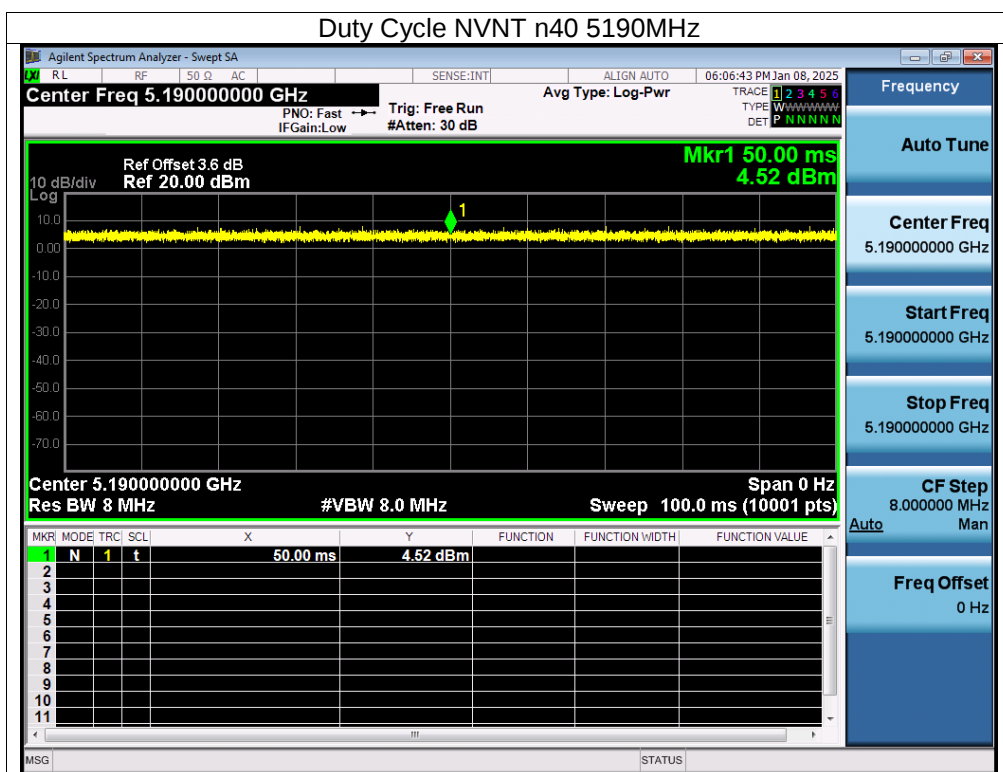
Test Graphs

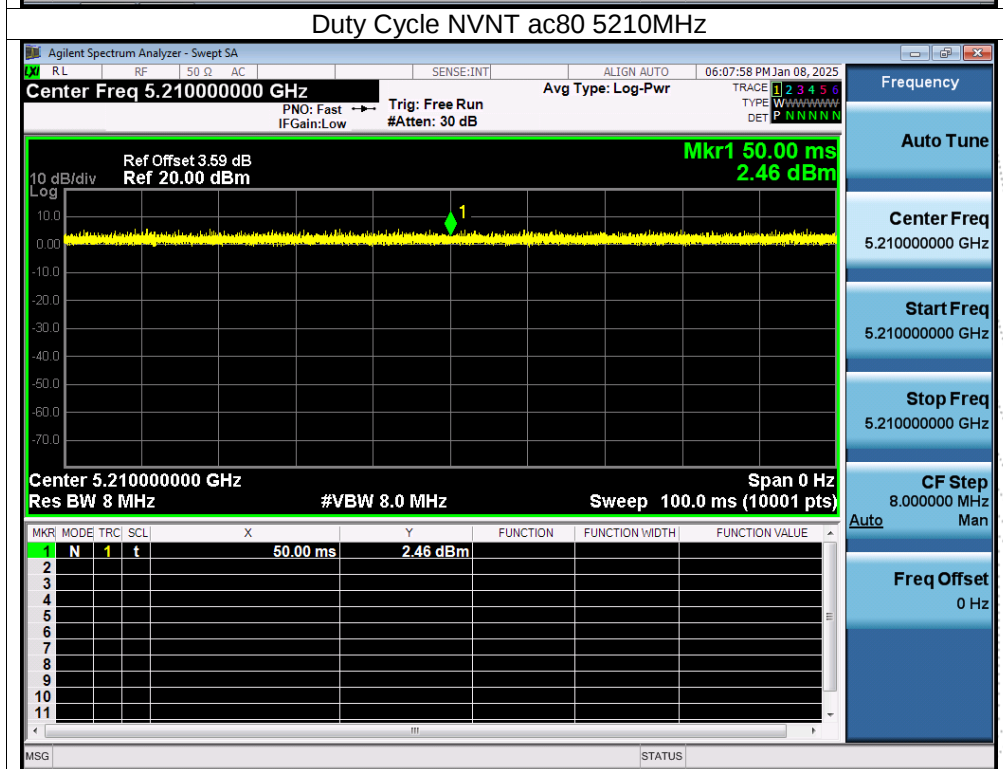
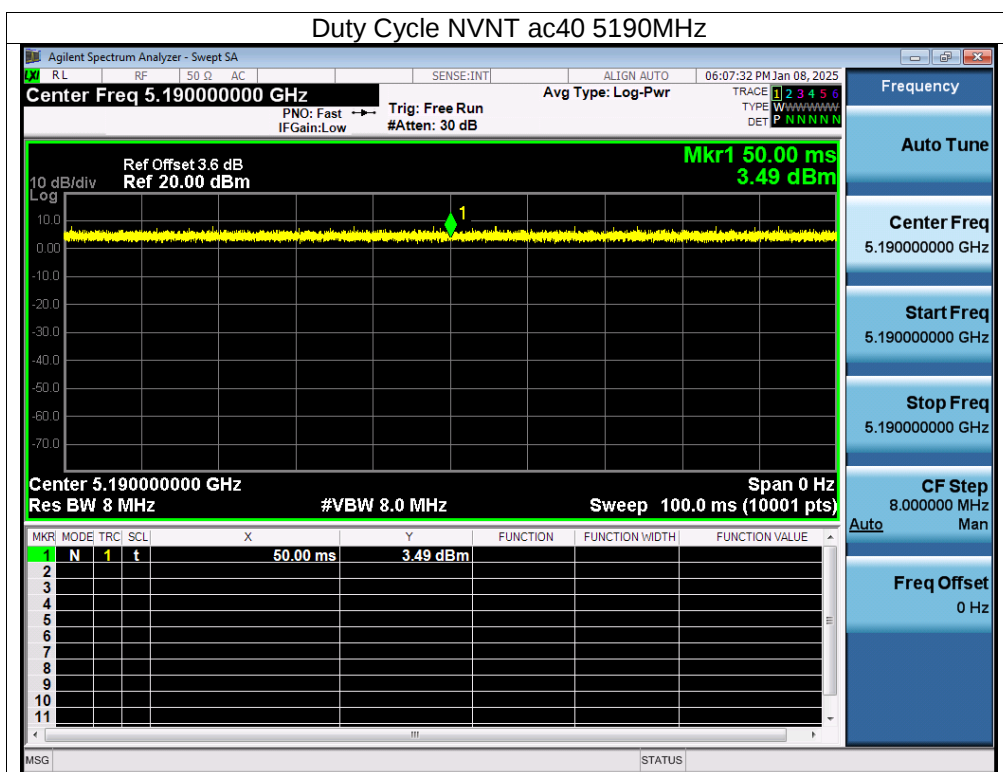
Duty Cycle NVNT a 5180MHz



Duty Cycle NVNT n20 5180MHz







5.8G

Condition	Mode	Frequency (MHz)	Duty Cycle (%)	Correction Factor (dB)	1/T (kHz)
NVNT	a	5745	100	0	0
NVNT	n20	5745	100	0	0
NVNT	n40	5755	100	0	0
NVNT	ac20	5745	100	0	0
NVNT	ac40	5755	100	0	0
NVNT	ac80	5775	100	0	0

